

TEST REPORT

Test report no.: 1-0087/20-01-03-A

BNetzA-CAB-02/21-102

Testing laboratory

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Accredited Testing Laboratory:

The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2018-03) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)

The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate starting with the registration number: D-PL-12076-01.

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Manufacturer

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Test standard/s

FCC - Title 47 CFR
Part 15

FCC - Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

RSS - 247 Issue 2

Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices

RSS - Gen Issue 5
incl. Amendment 1

Spectrum Management and Telecommunications Radio Standards Specification
- General Requirements for Compliance of Radio Apparatus

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item: Hiberband Via gateway

Model name: LoRaWAN gateway

FCC ID: 2ASDVVIA1

IC: 24744-VIA1

Frequency: 923.3MHz – 927.5 MHz operation frequency range

Technology tested: LoRa

Antenna: External antenna

Power supply: 10.0 V to 28.0 V DC by external power supply

Temperature range: -20°C to +70°C



This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CTC advanced GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

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This test report replaces the test report with the number 1-0087/20-01-03 and dated 2020-08-19.

2.2 Application details

Date of receipt of order:	2020-06-18
Date of receipt of test item:	2020-06-22
Start of test:	2020-06-24
End of test:	2020-07-06
Person(s) present during the test:	-/-

2.3 Test laboratories sub-contracted

None

3 Test standard/s, references and accreditations

Test standard	Date	Description
FCC - Title 47 CFR Part 15		FCC - Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 247 Issue 2	February 2017	Digital Transmission Systems (DTSs), Frequency Hopping Systems (FHSs) and Licence - Exempt Local Area Network (LE-LAN) Devices
RSS - Gen Issue 5 incl. Amendment 1	March 2019	Spectrum Management and Telecommunications Radio Standards Specification - General Requirements for Compliance of Radio Apparatus

Guidance	Version	Description
KDB 558074 D01	v05r02	GUIDANCE FOR COMPLIANCE MEASUREMENTS ON DIGITAL TRANSMISSION SYSTEM, FREQUENCY HOPPING SPREAD SPECTRUM SYSTEM, AND HYBRID SYSTEM DEVICES OPERATING UNDER SECTION 15.247 OF THE FCC RULES
ANSI C63.4-2014	-/-	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices

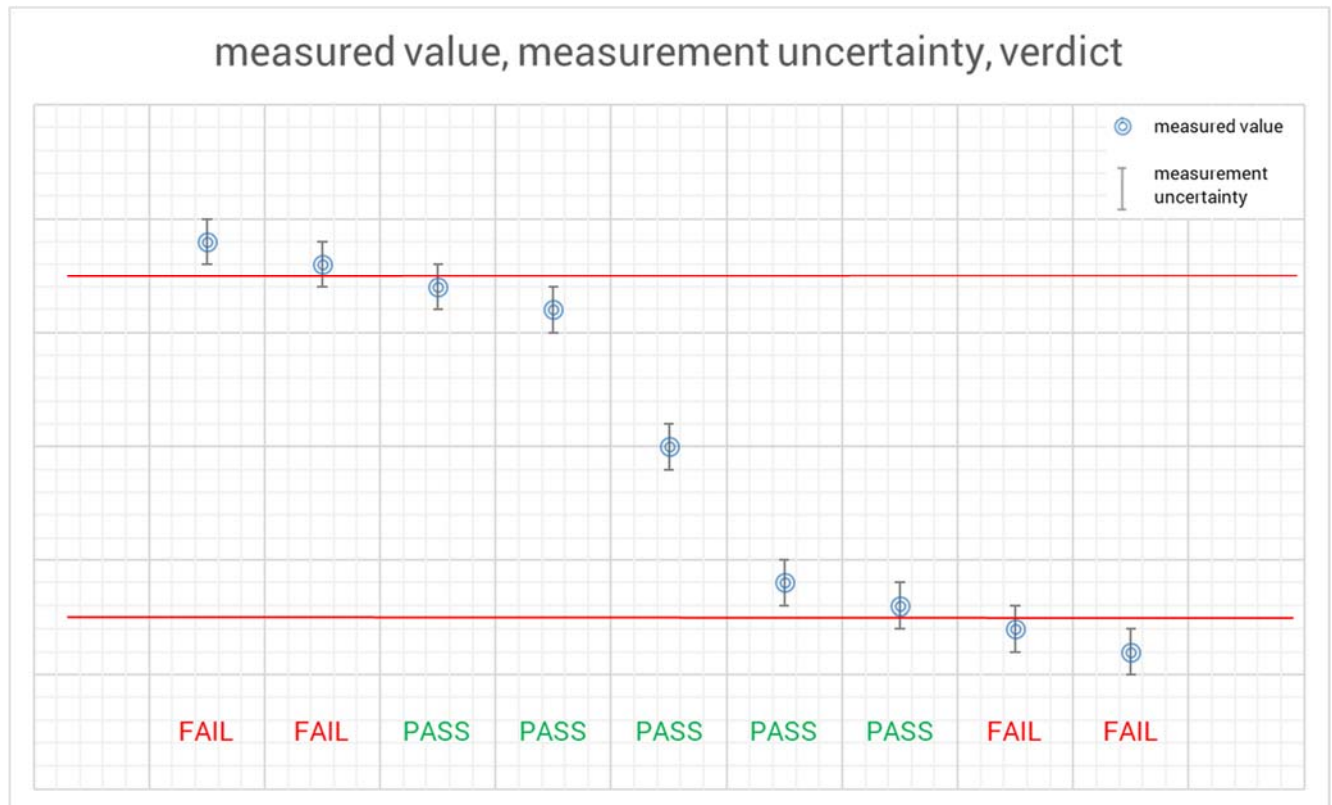
Accreditation	Description
D-PL-12076-01-04	Telecommunication and EMC Canada https://www.dakks.de/as/ast/d/D-PL-12076-01-04.pdf
D-PL-12076-01-05	Telecommunication FCC requirements https://www.dakks.de/as/ast/d/D-PL-12076-01-05.pdf



4 Reporting statements of conformity – decision rule

Only the measured values related to their corresponding limits will be used to decide whether the equipment under test meets the requirements of the test standards listed in chapter 3.

The measurement uncertainty is mentioned in this test report, see chapter 9, but is not taken into account - neither to the limits nor to the measurement results. Measurement results with a smaller margin to the corresponding limits than the measurement uncertainty have a potential risk of more than 5% that the decision might be wrong."



5 Test environment

Temperature	:	T_{nom} T_{max} T_{min}	+22 °C during room temperature tests +70 °C during high temperature tests* -20 °C during low temperature tests*
Relative humidity content	:		55 %
Barometric pressure	:		1021 hpa
Power supply	:	V_{nom} V_{max} V_{min}	12.0 V DC by external power supply 28.0 V* 10.0 V*

*No tests under extreme conditions required.

6 Test item

6.1 General description

Kind of test item	:	Hiberband Via gateway
Model name	:	LoRaWAN gateway
HMN	:	-/-
PMN	:	Hiberband Via
HVIN	:	VIA1
FVIN	:	-/-
S/N serial number	:	AB20F000038
Hardware status	:	A2
Software status	:	A2
Firmware status	:	A2
Frequency band	:	ISM band 902 MHz – 928 MHz (923.3MHz – 927.5 MHz operation frequency range)
Type of radio transmission	:	Modulated carrier
Use of frequency spectrum	:	
Type of modulation	:	LoRa; GFSK
Number of channels	:	8
Antenna	:	External antenna
Power supply	:	10.0 V to 28.0 V DC by external power supply
Temperature range	:	-20°C to +70°C

6.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup and EUT photos are included in test report:

1-0087/20-01-01_AnnexA
 1-0087/20-01-01_AnnexB
 1-0087/20-01-01_AnnexD

7 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

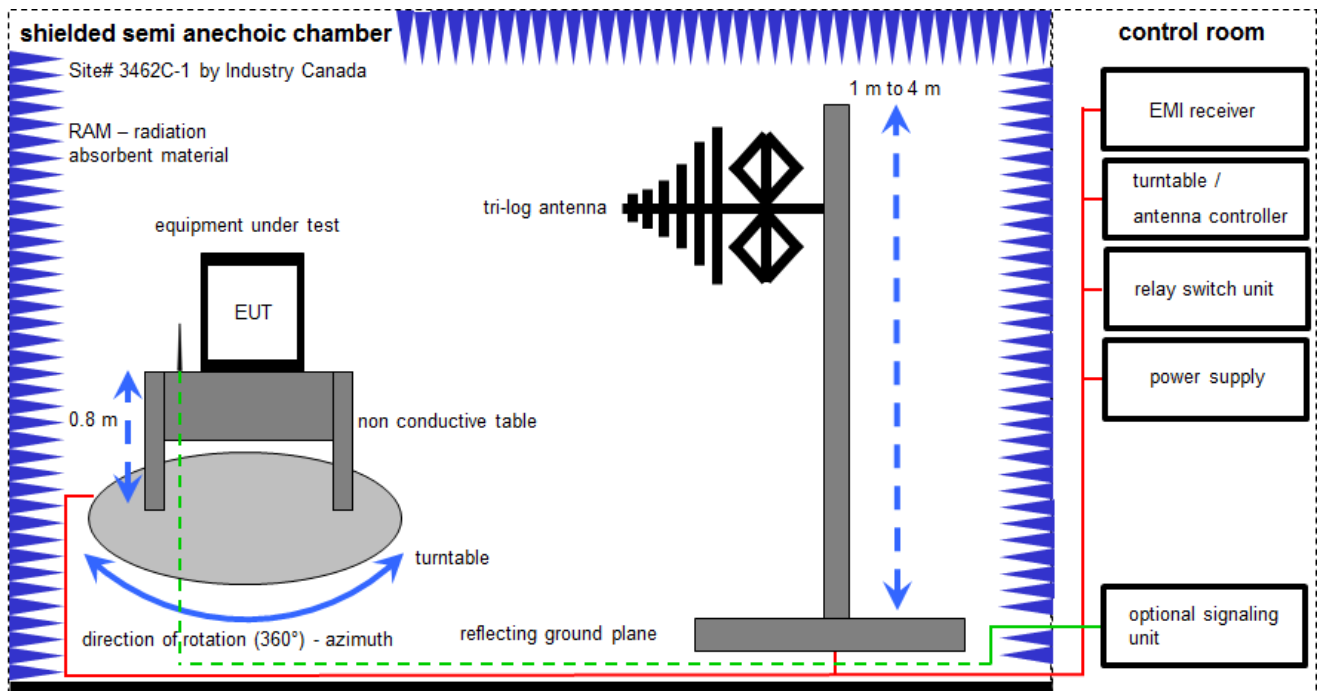
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vlk!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

7.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 30 MHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are conform to specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter
 EMC32 software version: 10.30.0

FS = UR + CL + AF

(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

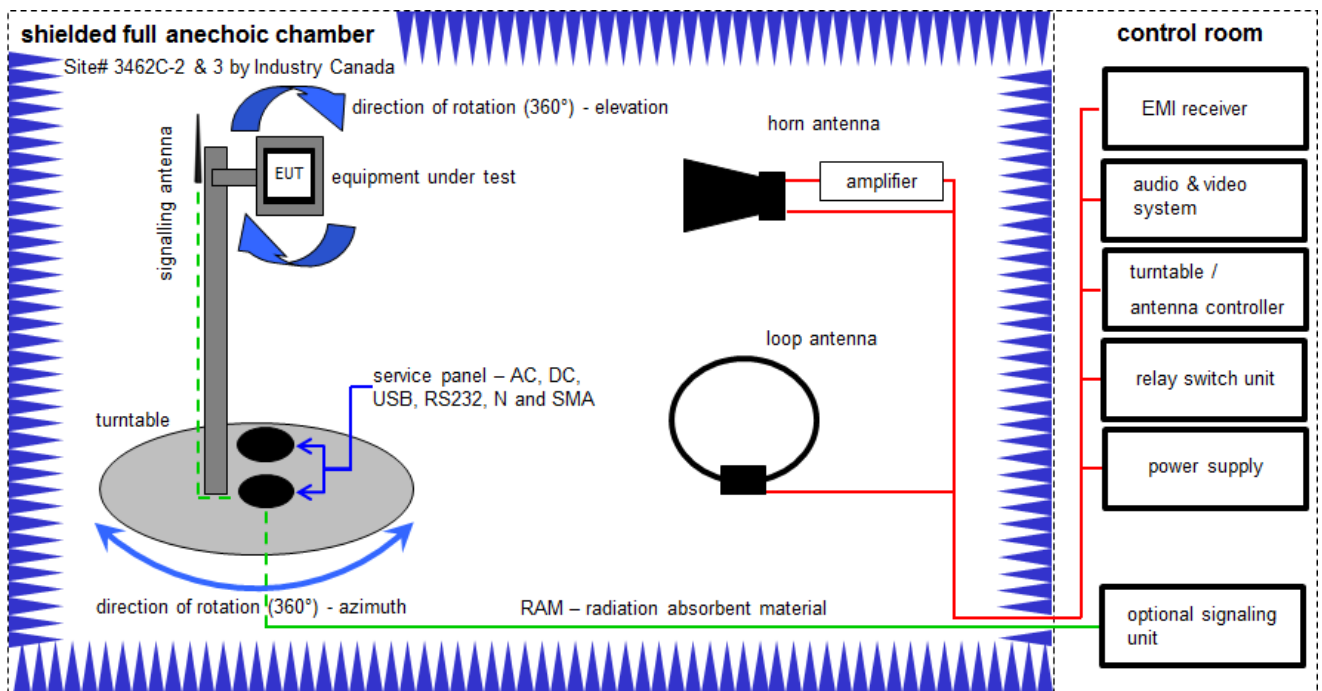
Example calculation:

FS [dBμV/m] = 12.35 [dBμV/m] + 1.90 [dB] + 16.80 [dB/m] = 31.05 [dBμV/m] (35.69 μV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
2	A	Meßkabine 1	HF-Absorberhalle	MWB AG 300023		300000551	ne	-/-	-/-
3	A	Analyzer-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	vIKI!	17.01.2020	16.01.2022
4	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
5	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
6	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
7	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck Mess - Elektronik	295	300003787	vIKI!	19.02.2019	18.02.2021
8	A	EMI Test Receiver	ESR3	Rohde & Schwarz	102587	300005771	k	21.05.2019	20.11.2020

7.2 Shielded fully anechoic chamber



Measurement distance: horn antenna 3 meter; loop antenna 3 meter

FS = UR + CA + AF

(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

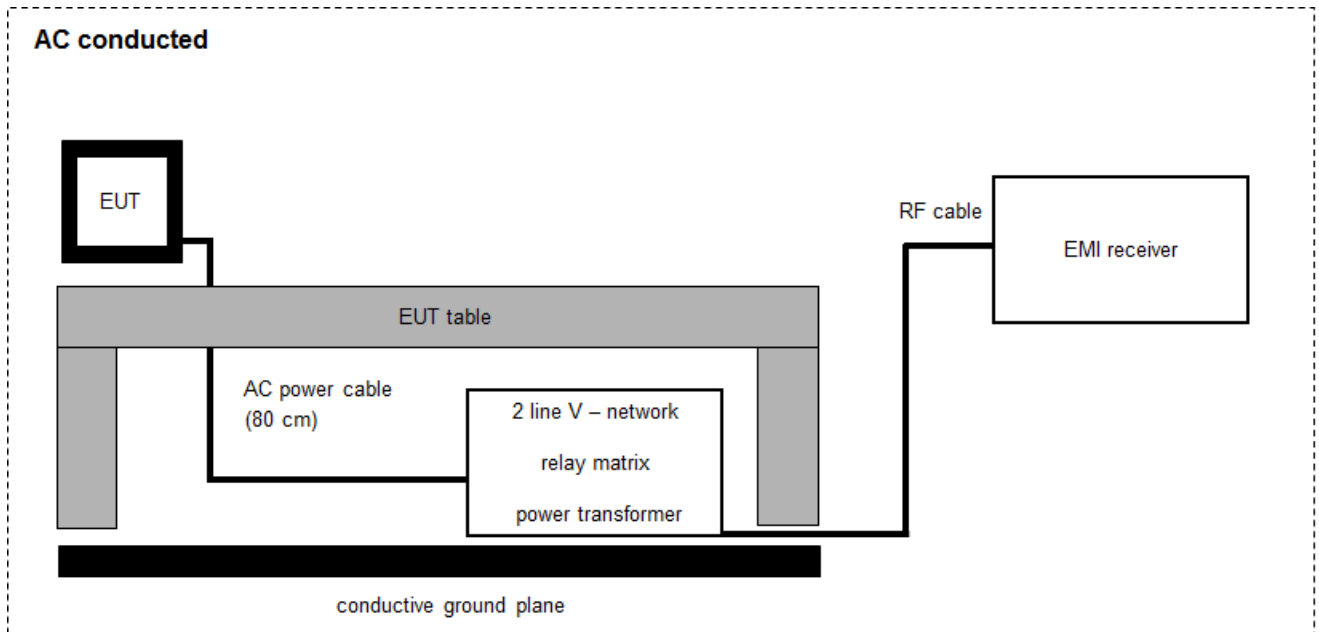
Example calculation:

FS [dBμV/m] = 40.0 [dBμV/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dBμV/m] (71.61 μV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Active Loop Antenna 9 kHz to 30 MHz	6502	EMCO	2210	300001015	vIKI!	13.06.2019	12.06.2021
2	C, D	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	9107-3696	300001604	vIKI!	27.02.2019	26.02.2021
3	C	Highpass Filter	WHK1.1/15G-10SS	Wainwright	37	400000148	ne	-/-	-/-
4	D	Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	ne	-/-	-/-
5	C	Broadband Amplifier 0.5-18 GHz	CBLU5184540	CERNEX	22051	300004483	ev	-/-	-/-
6	A,B,C, D	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000032	300004510	ne	-/-	-/-
7	A,B,C, D	Computer	Intel Core i3 3220/3,3 GHz, Prozessor		2V2403033A54 21	300004591	ne	-/-	-/-
8	A,B,C, D	NEXIO EMV-Software	BAT EMC V3.19.1.21	EMCO		300004682	ne	-/-	-/-
9	A,B,C, D	Anechoic chamber		TDK		300003726	ne	-/-	-/-
10	A,B,C, D	EMI Test Receiver 9kHz-26,5GHz	ESR26	R&S	101376	300005063	k	10.12.2019	09.12.2020
11	B	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck Mess - Elektronik	01029	300005379	vIKI!	02.07.2019	01.07.2021
12	D	RF-Amplifier	AMF-6F06001800-30-10P-R	NARDA-MITEQ Inc	2011571	300005240	ev	-/-	-/-

7.3 AC conducted



$$FS = UR + CF + VC$$

(FS-field strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

Example calculation:

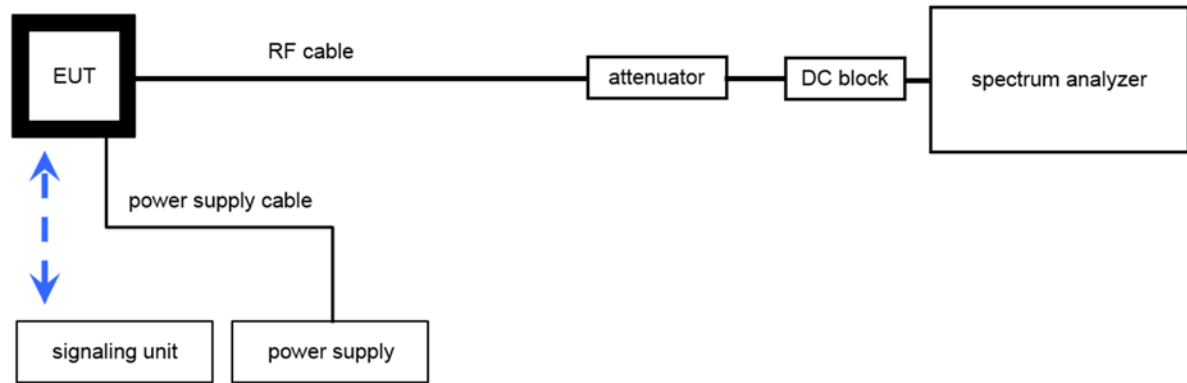
$$FS \text{ [dB}\mu\text{V/m]} = 37.62 \text{ [dB}\mu\text{V/m]} + 9.90 \text{ [dB]} + 0.23 \text{ [dB]} = 47.75 \text{ [dB}\mu\text{V/m]} \text{ (244.06 } \mu\text{V/m)}$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Two-line V-Network (LISN) 9 kHz to 30 MHz	ESH3-Z5	R&S	892475/017	300002209	vIKII	11.12.2019	10.12.2021
2	A	RF-Filter-section	85420E	HP	3427A00162	300002214	NK!	-/-	-/-
3	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	10.12.2019	09.12.2020
4	A	Hochpass 150 kHz	EZ-25	R&S	100010	300003798	ev	-/-	-/-

7.4 Conducted measurements

Conducted measurements normal conditions



$$OP = AV + CA$$

(OP-output power; AV-analyzer value; CA-loss signal path)

Example calculation:

$$OP \text{ [dBm]} = 6.0 \text{ [dBm]} + 11.7 \text{ [dB]} = 17.7 \text{ [dBm]} \text{ (58.88 mW)}$$

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Signal- and Spectrum Analyzer 2 Hz - 26 GHz	FSW26	R&S	101455	300004528	k	24.02.2020	23.02.2021
2	A	RF-Cable SRD021 No. 1	Enviroflex 316 D	Huber & Suhner		400001311	ev	-/-	-/-

8 Sequence of testing

8.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, it is placed on a table with 0.8 m height.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement*

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the pre-measurement are maximized by the software by rotating the turntable from 0° to 360°.
- Loop antenna is rotated about its vertical axis for maximum response at each azimuth about the EUT. (For certain applications, the loop antenna plane may also need to be positioned horizontally at the specified distance from the EUT)
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

*)Note: The sequence will be repeated three times with different EUT orientations.

8.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position $\pm 45^\circ$ and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

8.3 Sequence of testing radiated spurious 1 GHz to 12.75 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height is 1.5 m.
- At each turntable position and antenna polarization the analyzer sweeps with positive peak detector to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximizes the peaks by rotating the turntable from 0° to 360°. This measurement is repeated for different EUT-table positions (0° to 150° in 30°-steps) and for both antenna polarizations.
- The final measurement is done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

9 Measurement uncertainty

Measurement uncertainty	
Test case	Uncertainty
Antenna gain	± 3 dB
Carrier frequency separation	± 21.5 kHz
Number of hopping channels	-/-
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative
Maximum output power	± 1 dB
Detailed conducted spurious emissions @ the band edge	± 1 dB
Band edge compliance radiated	± 3 dB
Spurious emissions conducted	± 3 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB
Spurious emissions radiated above 12.75 GHz	± 4.5 dB

10 Summary of measurement results

☒	No deviations from the technical specifications were ascertained
☐	There were deviations from the technical specifications ascertained
☐	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

10.1 DSSS

Test specification clause	Test case	Temperature conditions	Power source voltages	Mode	C	NC	NA	NP	Remark
§15.247(b)(4) RSS 210 / A8.4(2)	Antenna gain	Nominal	Nominal	TX single channel	☒	☐	☐	☐	-/-
§15.247(e) RSS - 247 / 5.2 (b)	Power spectral density	Nominal	Nominal	TX single channel	☒	☐	☐	☐	-/-
§15.247(a)(2) RSS Gen clause 4.6.1	Spectrum bandwidth 6dB bandwidth	Nominal	Nominal	TX single channel	☒	☐	☐	☐	-/-
§15.247(b)(3) RSS - 247 / 5.4 (d)	Maximum output power	Nominal	Nominal	TX single channel	☒	☐	☐	☐	-/-
§15.205 RSS - 247 / 5.5 RSS - Gen	Band edge compliance conducted	Nominal	Nominal	TX single channel	☒	☐	☐	☐	-/-
§15.205 RSS - 247 / 5.5 RSS - Gen	Band edge compliance radiated	Nominal	Nominal	-/-	☒	☐	☐	☐	-/-
§§15.247(d) RSS - 247 / 5.5	TX spurious emissions conducted	Nominal	Nominal	TX single channel	☒	☐	☐	☐	-/-
§15.247(d) RSS-210 / A8.5	TX spurious emissions radiated	Nominal	Nominal	TX single channel	☒	☐	☐	☐	-/-
§15.109 RSS-Gen.	RX spurious emissions radiated	Nominal	Nominal	RX	☒	☐	☐	☐	-/-
§15.209(a) RSS-Gen	TX spurious emissions radiated < 30 MHz	Nominal	Nominal	TX single channel	☒	☐	☐	☐	-/-
§15.107(a) §15.207	Conducted emissions < 30 MHz	Nominal	Nominal	TX hybrid	☒	☐	☐	☐	-/-

Note: C = Compliant; NC = Not compliant; NA = Not applicable; NP = Not performed

11 RF measurements

11.1 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: DSSS: 8 channels with 500 kHz nominal bandwidth and 1600 kHz channel spacing

lowest channel	923.3 MHz,
middle channel	925.1 MHz,
highest channel	927.5 MHz;

(these channels were tested in this test report).

Test mode: ☒ Special software is used.
EUT is transmitting pseudo random data by itself

12 Measurement results DSSS

12.1 Maximum output power

Measurement:

Measurement parameter	
Detector:	RMS
Sweep time:	Auto
Resolution bandwidth:	10 kHz
Video bandwidth:	100 kHz
Span:	1 MHz
Trace-Mode:	Max Hold
Measurement method	According to ANSI C63.10-2013 11.9.2.2.3 Method AVGSA-1A (alternative)
Used equipment:	See chapter 7.2A & 7.4A
Measurement uncertainty:	See chapter 9

Limits:

FCC	IC
1 watt (30 dBm) Maximum Output Power Conducted	

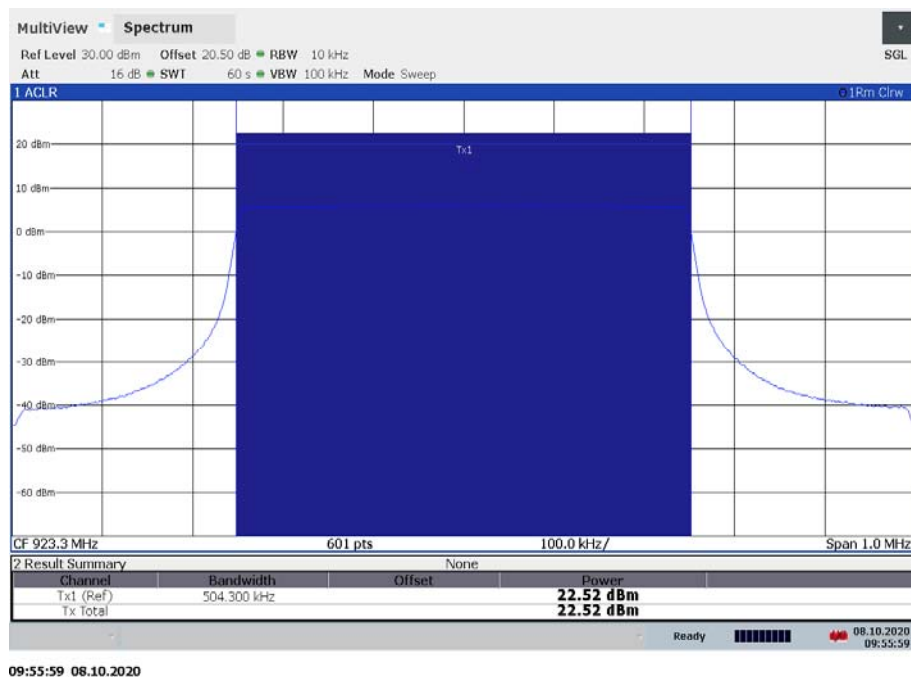
Result:

Test Conditions		Maximum Output Power Conducted / dBm		
		Low channel	Middle channel	High channel
T_{nom}	V_{nom}	22.5	22.3	22.1

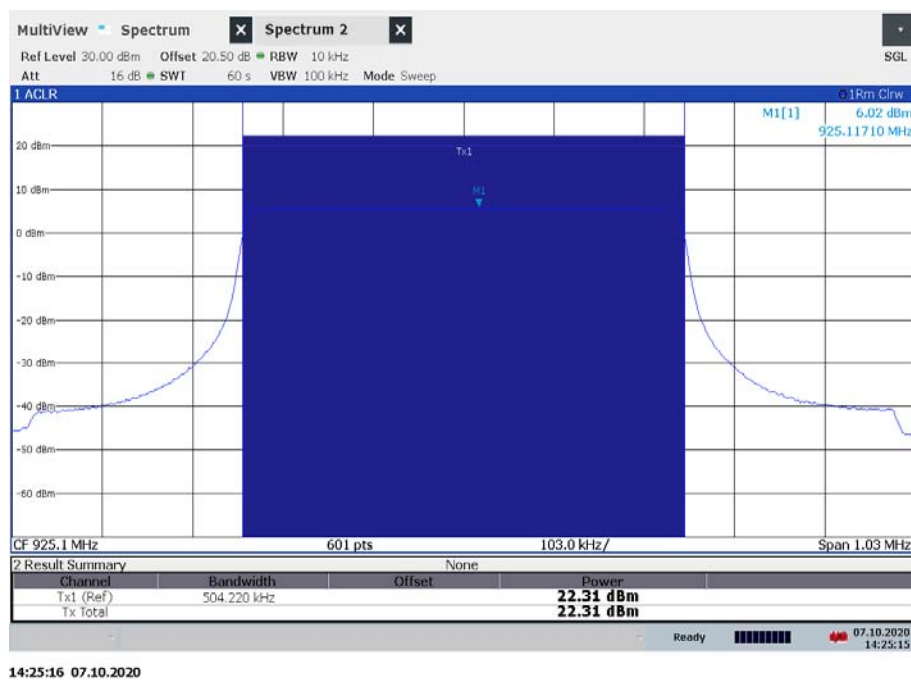
Test Conditions		EIRP / dBm		
		Low channel	Middle channel	High channel
T_{nom}	V_{nom}	29.3	28.7	28.9

Plots conducted:

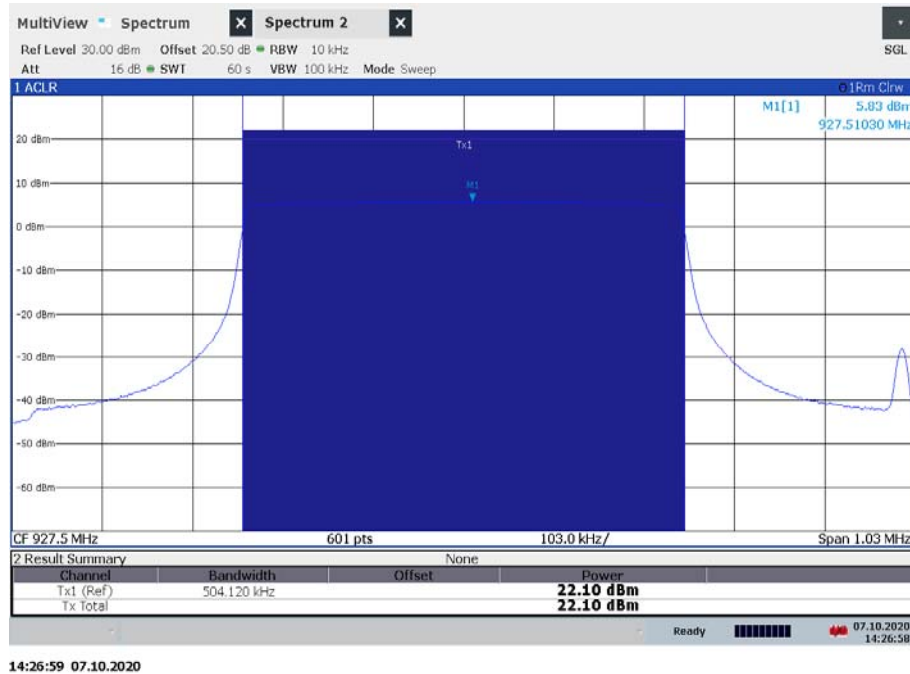
Plot 1: Low Channel



Plot 2: Middle Channel



Plot 3: High Channel



12.2 Antenna gain

Description:

The antenna gain of the complete system is calculated by the difference of radiated power in EIRP and the conducted power of the module.

Measurement:

Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 MHz
Span	5 MHz
Trace mode	Max hold
Test setup	See sub clause 7.2 A (radiated) See sub clause 7.4 A (conducted)
Measurement uncertainty	See sub clause 8

Limits:

FCC	IC
Antenna gain	
The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.	

Results:

	Low channel	Middle channel	High channel
Conducted power / dBm	22.8	22.8	22.6
Radiated power / dBm ERP	27.6	27.1	27.3
Gain / dBd (Calculated)	+4.8	+4.3	+4.7
Gain / dBi (Calculated)	+6.9	+6.4	+6.8

Plots conducted:

Plot 1: Low Channel



Plot 2: Middle Channel



Plot 3: High Channel



12.3 Power spectral density

Description:

Measurement of the power spectral density of a digital modulated system. The measurement is repeated at the lowest, middle and highest channel.

Measurement:

Measurement parameter	
Detector:	RMS
Sweep time:	10 s
Video bandwidth:	10 kHz
Resolution bandwidth:	3 kHz
Span:	1.5 MHz
Trace-Mode:	Max Hold
Measurement method	According to ANSI C63.10-2013 11.10.4 (Method AVGPDS-1A alternative)
Test setup	See sub clause 7.4 A
Measurement uncertainty	See sub clause 9

Limits:

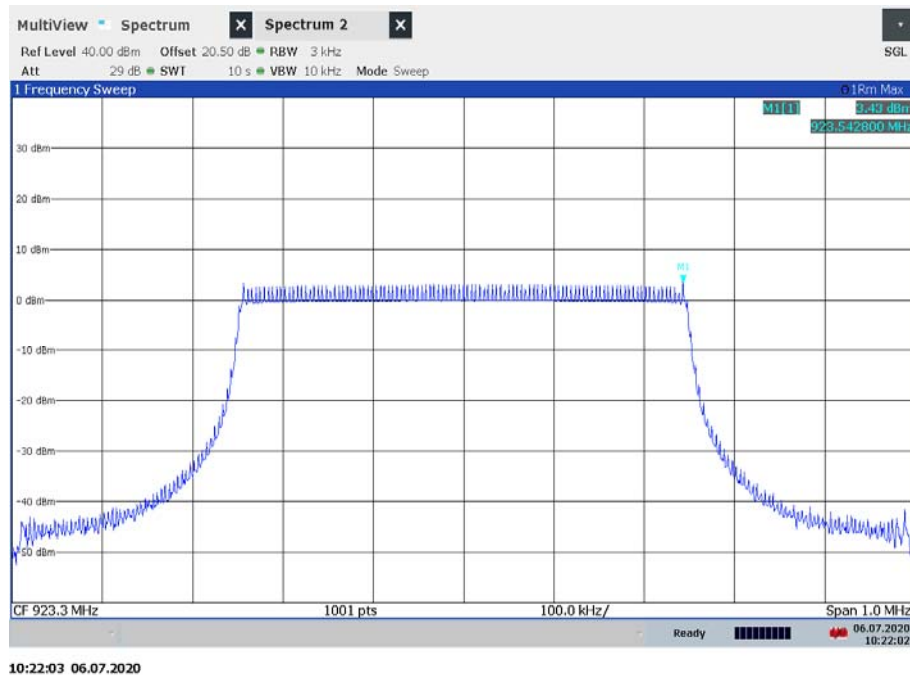
FCC	IC
Power Spectral Density	
The transmitter power spectral density conducted from the transmitter to the antenna shall not be greater than 8 dBm in any 3 kHz band during any time interval of continuous transmission or over 1.0 second if the transmission exceeds 1.0-second duration.	

Results:

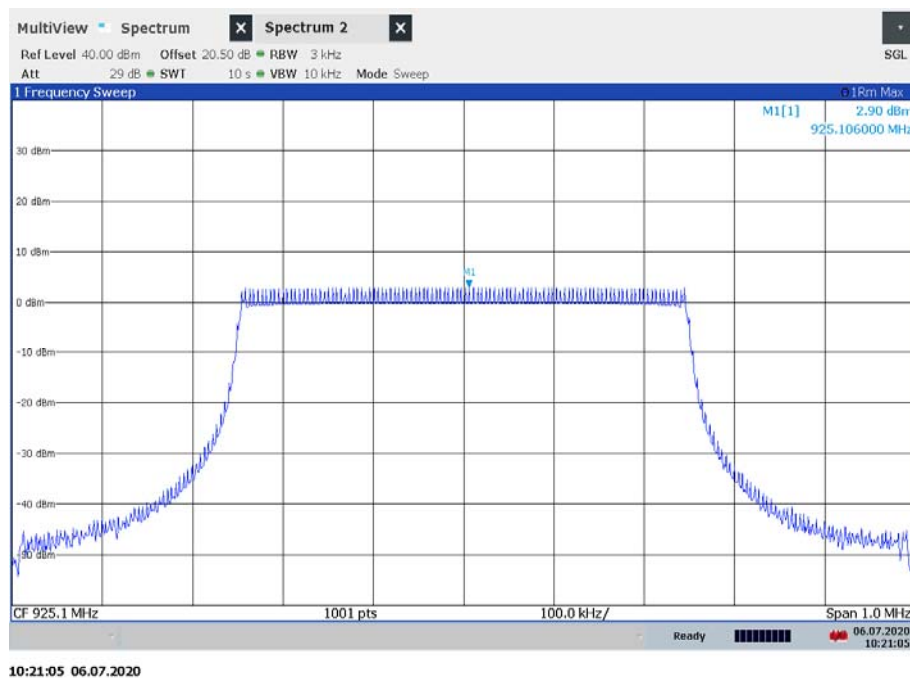
Modulation Channel	Power Spectral density / (dBm/3kHz)		
	Lowest	Middle	Highest
	3.43	2.90	2.98

Plots:

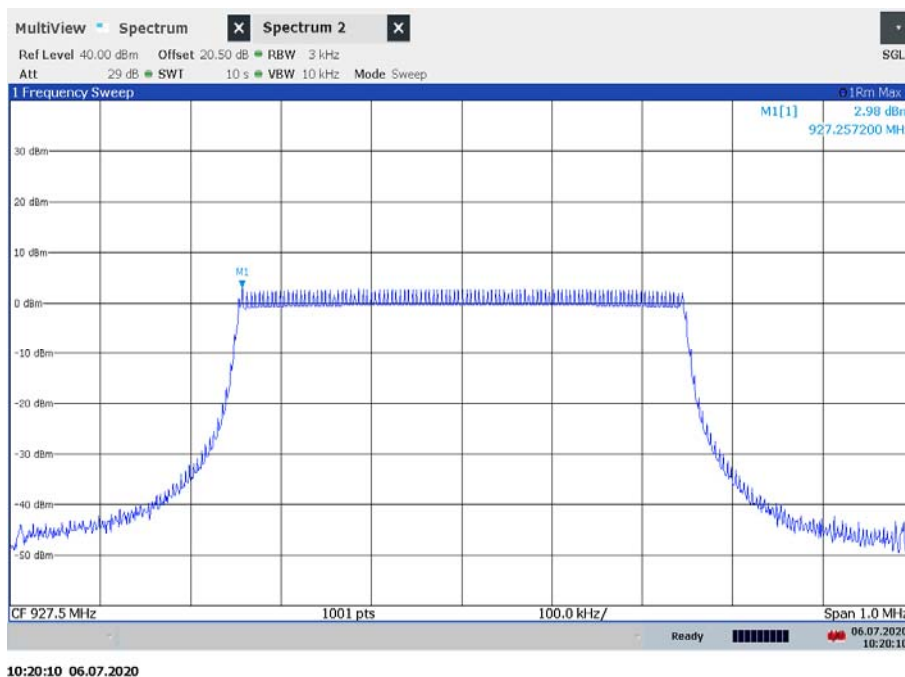
Plot 1: Low Channel



Plot 2: Middle Channel



Plot 3: High Channel



12.4 Spectrum bandwidth – 6 dB bandwidth and 99% bandwidth

Description:

Measurement of the 6 dB and OBW 99% bandwidth of the modulated signal.

Measurement:

Measurement parameter	
Detector:	Peak
Sweep time:	Auto
Video bandwidth:	10 kHz (OBW 99%) 100 kHz (6dB-BW)
Resolution bandwidth:	100 kHz (OBW 99%) 300 kHz (6dB-BW)
Span:	See plots
Trace-Mode:	Max Hold
Test setup	See sub clause 7.4 A
Measurement uncertainty	See sub clause 9

Limits:

FCC	IC
Spectrum Bandwidth – 6 dB Bandwidth	
The minimum 6 dB bandwidth shall be at least 500 kHz.	

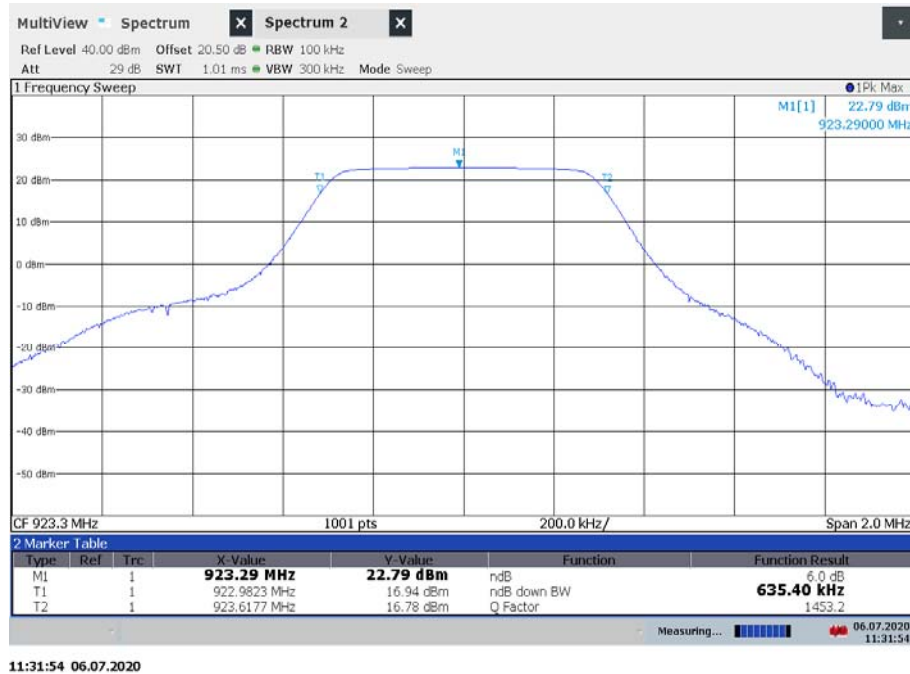
Results:

Test Conditions		6 dB Bandwidth / kHz		
		Low channel	Middle channel	High channel
T_{nom}	V_{nom}	635.4	635.4	635.4

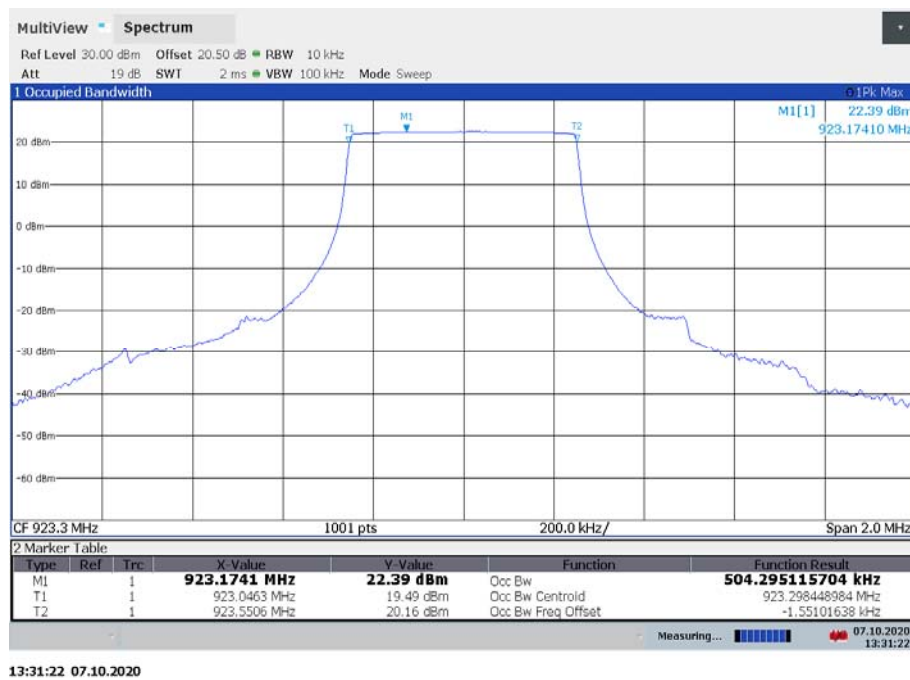
Test Conditions		99% Bandwidth / kHz		
		Low channel	Middle channel	High channel
T_{nom}	V_{nom}	504.29	504.21	504.12

Plots:

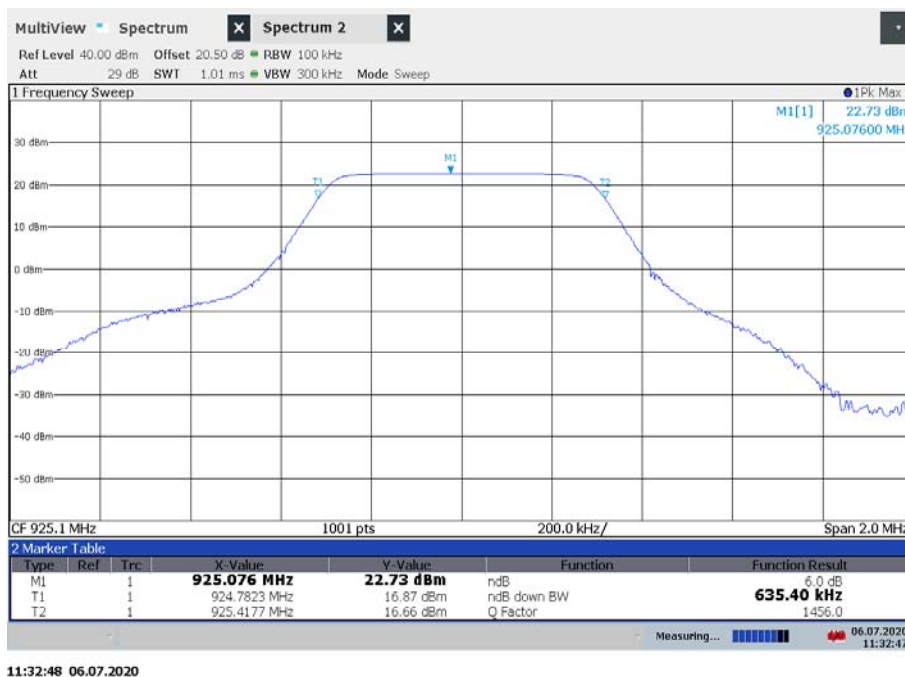
Plot 1: Low Channel, 6 dB-BW



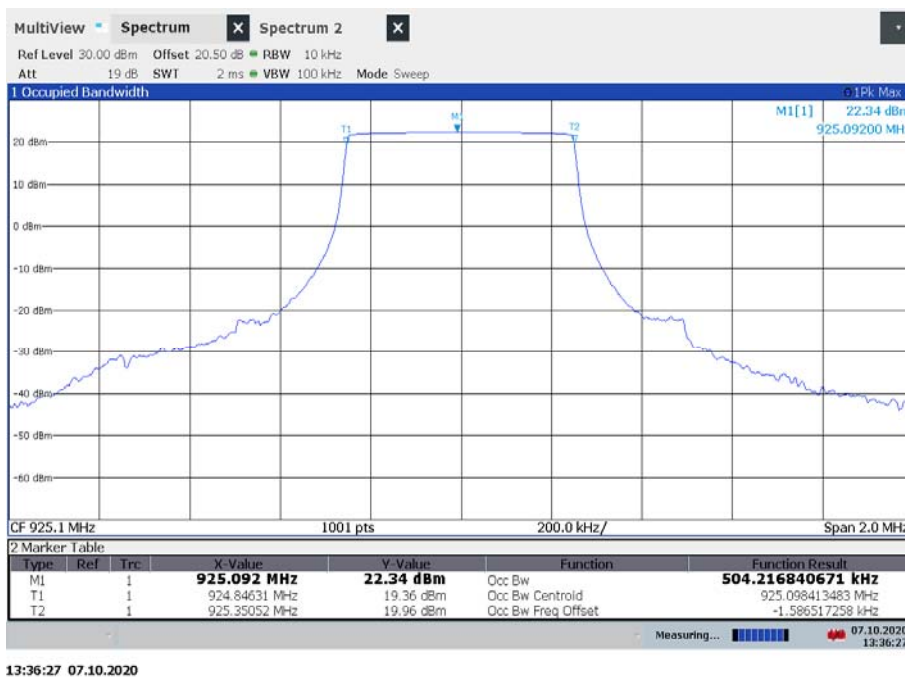
Plot 2: Low Channel, 99%OBW



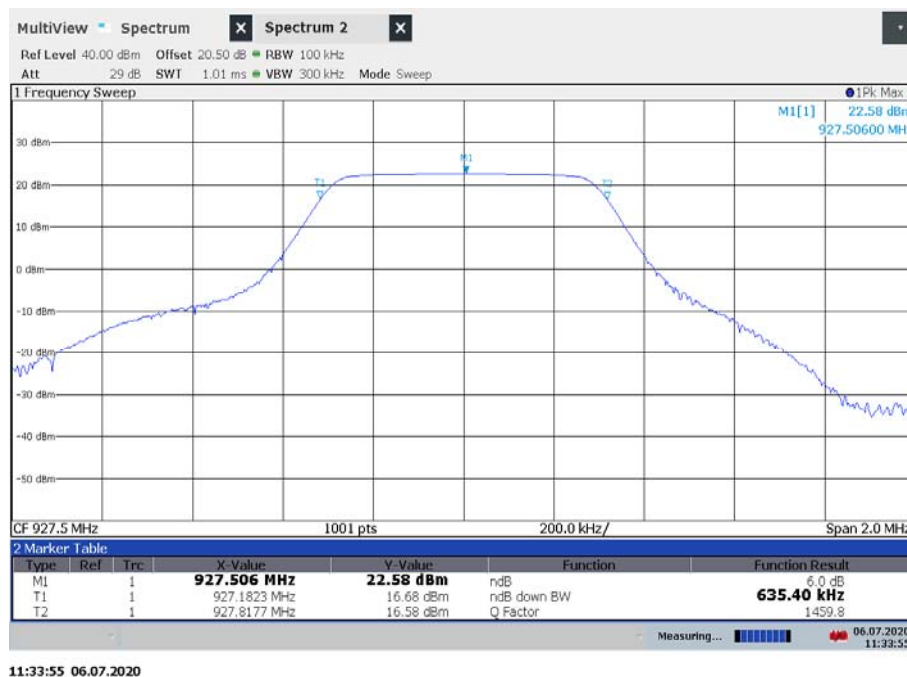
Plot 3: Middle Channel, 6 dB-BW



Plot 4: Middle Channel, 99%OBW



Plot 5: High Channel, 6 dB-BW



Plot 6: High Channel, 99%OBW



12.5 Detailed spurious emissions @ the band edge – conducted and radiated

Description:

Measurement of the conducted band edge compliance. EUT is measured at the lower and upper band edge in single channel mode.

Measurement:

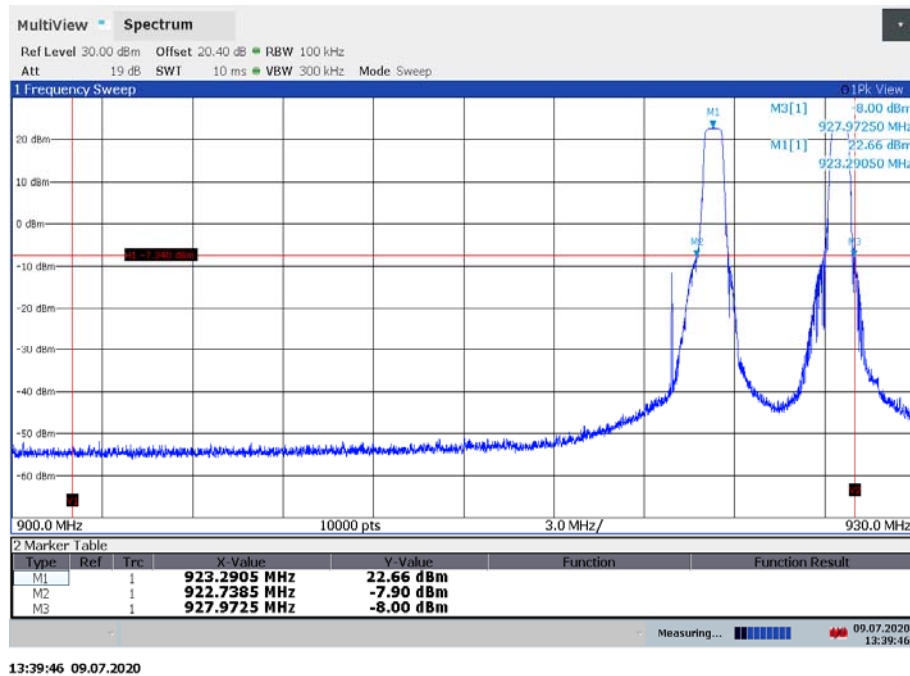
Measurement parameters	
Detector	Peak
Sweep time	Auto
Resolution bandwidth	100 kHz
Video bandwidth	300 kHz
Span	Lower Band Edge: 902 MHz Upper Band Edge: 928 MHz
Trace mode	Max hold
Test setup	See sub clause 7.4 A
Measurement uncertainty	See sub clause 9

Limits:

FCC	IC
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required.	RSS-247, Issue 2: 5.5 Unwanted emissions: In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of root-mean-square averaging over a time interval, as permitted under section 5.4(d), the attenuation required shall be 30 dB instead of 20 dB. Attenuation below the general field strength limits specified in RSS-Gen is not required.

Results conducted:

Scenario Modulation	Spurious band edge conducted / dB		
	lowest channel	middle channel	highest channel
Lower band edge – single channel mode	> 30 dB	> 30 dB	> 30 dB
Upper band edge – single channel mode	> 30 dB	> 30 dB	> 30 dB

Plots:**Plot 1: lowest and highest channel**

Results radiated:

No restricted band in the range ± 2 channel bandwidths of the Band-edges of the specified emission band! (608 MHz – 614 MHz and 960 MHz – 1240 MHz).

Section 15.205 Restricted bands of operation.

(a) Except as shown in paragraph (d) of this section, only spurious emissions are permitted in any of the frequency bands listed below:

MHz	MHz	MHz	GHz
0.090 - 0.110	16.42 - 16.423	399.9 - 410	4.5 - 5.15
¹ 0.495 - 0.505	16.69475 - 16.69525	608 - 614	5.35 - 5.46
2.1735 - 2.1905	16.80425 - 16.80475	960 - 1240	7.25 - 7.75
4.125 - 4.128	25.5 - 25.67	1300 - 1427	8.025 - 8.5
4.17725 - 4.17775	37.5 - 38.25	1435 - 1626.5	9.0 - 9.2
4.20725 - 4.20775	73 - 74.6	1645.5 - 1646.5	9.3 - 9.5
6.215 - 6.218	74.8 - 75.2	1660 - 1710	10.6 - 12.7
6.26775 - 6.26825	108 - 121.94	1718.8 - 1722.2	13.25 - 13.4
6.31175 - 6.31225	123 - 138	2200 - 2300	14.47 - 14.5
8.291 - 8.294	149.9 - 150.05	2310 - 2390	15.35 - 16.2
8.362 - 8.366	156.52475 - 156.52525	2483.5 - 2500	17.7 - 21.4
8.37625 - 8.38675	156.7 - 156.9	2690 - 2900	22.01 - 23.12
8.41425 - 8.41475	162.0125 - 167.17	3260 - 3267	23.6 - 24.0
12.29 - 12.293	167.72 - 173.2	3332 - 3339	31.2 - 31.8
12.51975 - 12.52025	240 - 285	3345.8 - 3358	36.43 - 36.5
12.57675 - 12.57725	322 - 335.4	3600 - 4400	(²)
13.36 - 13.41			

12.6 Spurious Emissions Conducted

Description:

Measurement of the conducted spurious emissions in transmit mode. The EUT is set to single channel mode. The measurement is repeated for low, mid and high channel.

Measurement:

Measurement parameter	
Detector:	Peak
Sweep time:	Auto
Video bandwidth:	F < 1 GHz: 1 MHz F > 1 GHz: 1 MHz
Resolution bandwidth:	F < 1 GHz: 100 kHz F > 1 GHz: 100 kHz
Span:	9 kHz to 12.75 GHz
Trace-Mode:	Max Hold
Used equipment:	See chapter 7.4A
Measurement uncertainty:	See chapter 9

Limits:

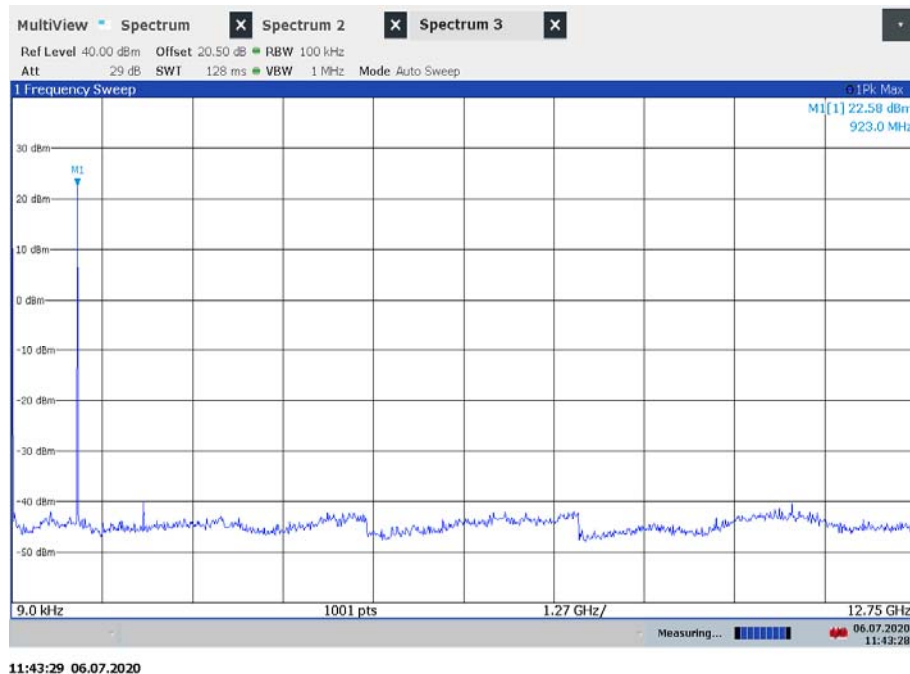
FCC	IC
TX spurious emissions conducted	
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required	
RSS-247, Issue 2: 5.5 Unwanted emissions: In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of root-mean-square averaging over a time interval, as permitted under section 5.4(d), the attenuation required shall be 30 dB instead of 20 dB. Attenuation below the general field strength limits specified in RSS-Gen is not required.	

Result:

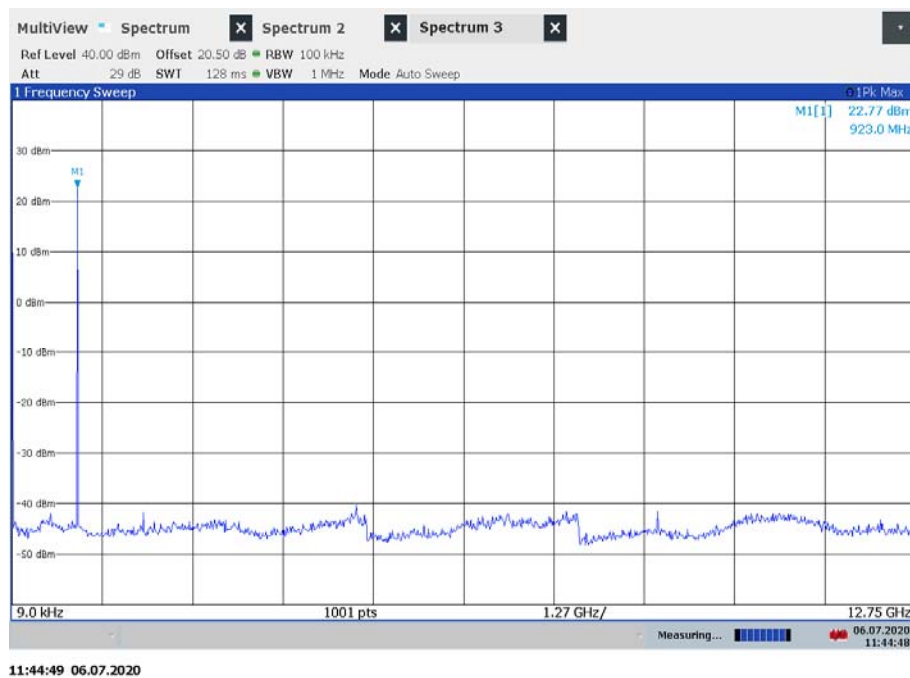
Emission Limitation					
Frequency / MHz		Amplitude of emission / dBm	Limit max. allowed emission power	actual attenuation below frequency of operation / dB	Results
923.3		22.58	24 dBm		Operating frequency
			-30 dBc	No emissions detected!	
925.1		22.77	24 dBm		Operating frequency
			-30 dBc	No emissions detected!	
927.5		22.60	24 dBm		Operating frequency
			-30 dBc	No emissions detected!	

Plots:

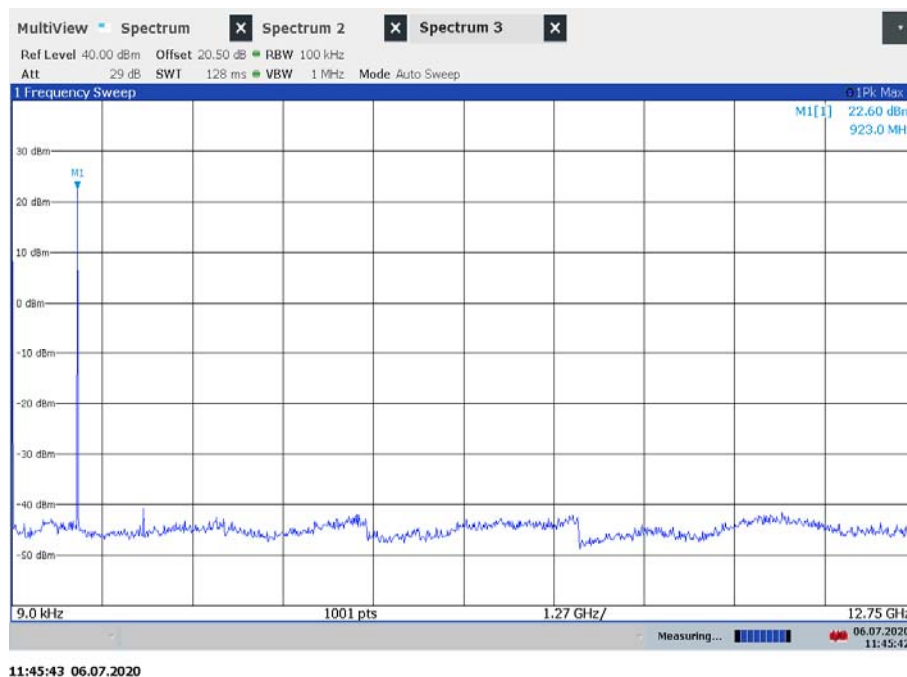
Plot 1: Low channel, 9 kHz – 12.75 GHz



Plot 2: Middle channel, 9 kHz – 12.75 GHz



Plot 3: High channel, 9 kHz – 12.75 GHz



12.7 Spurious Emissions Radiated < 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The EUT is set to single channel mode and the transmit channels are the lowest, middle and the highest channel. The measurement is performed in the mode with the highest output power. The limits are recalculated to a measurement distance of 3 m according the ANSI C63.10.

Measurement:

Measurement parameter	
Detector:	Peak / Quasi Peak
Sweep time:	Auto
Video bandwidth:	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Resolution bandwidth:	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span:	9 kHz to 30 MHz
Trace-Mode:	Max Hold
Used equipment:	See chapter 7.2 A
Measurement uncertainty:	See chapter 9

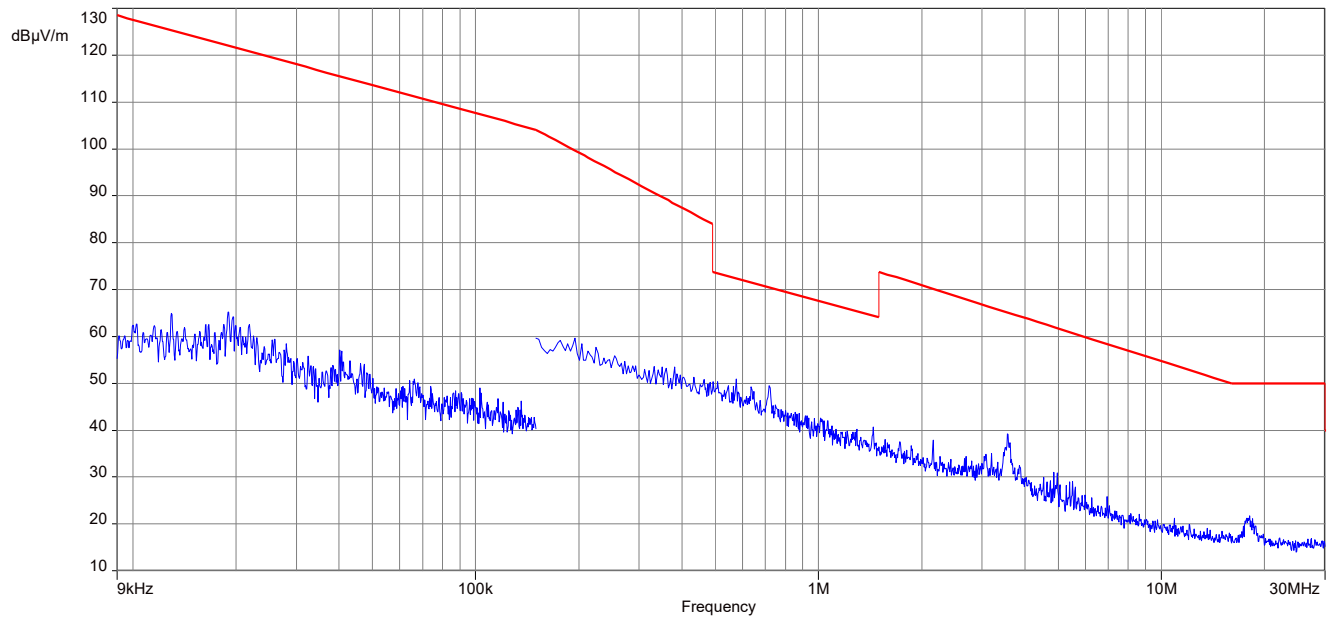
Limits:

FCC		IC
TX spurious emissions radiated < 30 MHz		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30.0	30	30

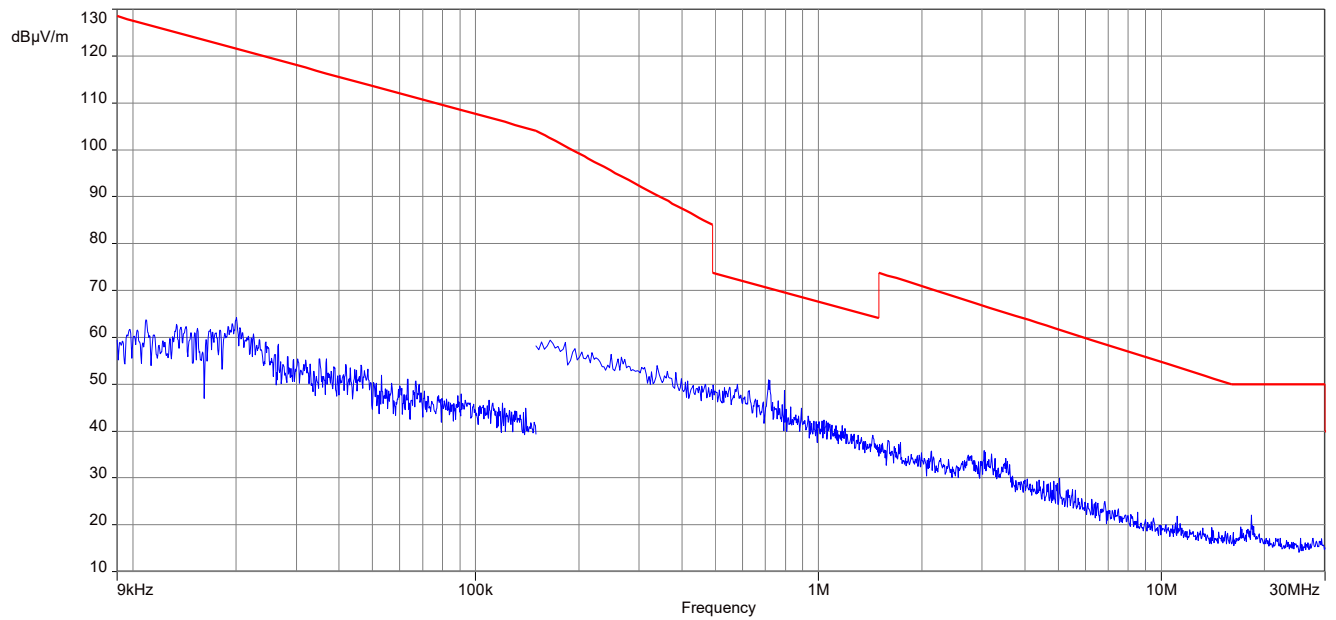
Result:

Spurious emission level								
Lowest channel			Middle channel			Highest channel		
Frequency / MHz	Detector	Level / (dBµV/m)	Frequency / MHz	Detector	Level / (dBµV/m)	Frequency / MHz	Detector	Level / (dBµV/m)
All emissions were more than 10 dB below the limit.								

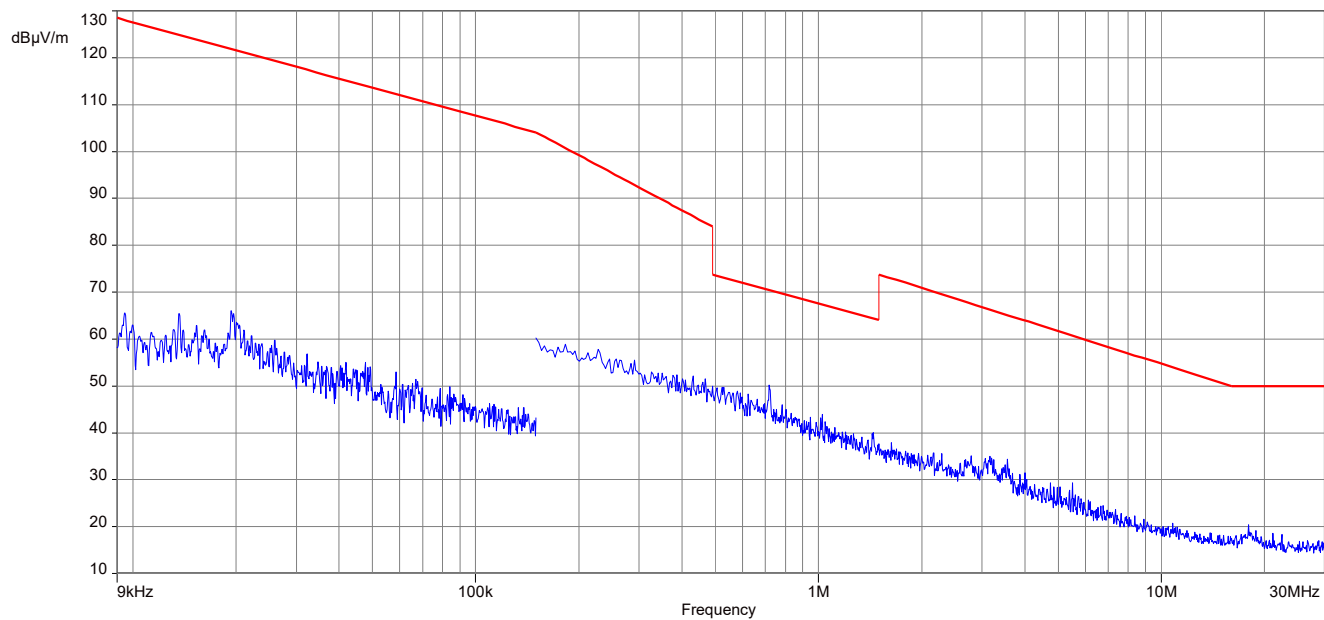
Plot 1: TX-Mode low channel



Plot 2: TX-Mode mid channel



Plot 3: TX-Mode high channel



12.8 Spurious Emissions Radiated > 30 MHz

12.8.1 Spurious emissions radiated 30 MHz to 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The measurement is performed at channel low, mid and high.

Measurement:

Measurement parameters	
Detector	Peak / Quasi Peak
Sweep time	Auto
Resolution bandwidth	3 x VBW
Video bandwidth	120 kHz
Span	30 MHz to 1 GHz
Trace mode	Max hold
Measured modulation	DSSS
Test setup	See sub clause 7.1 A
Measurement uncertainty	See sub clause 9

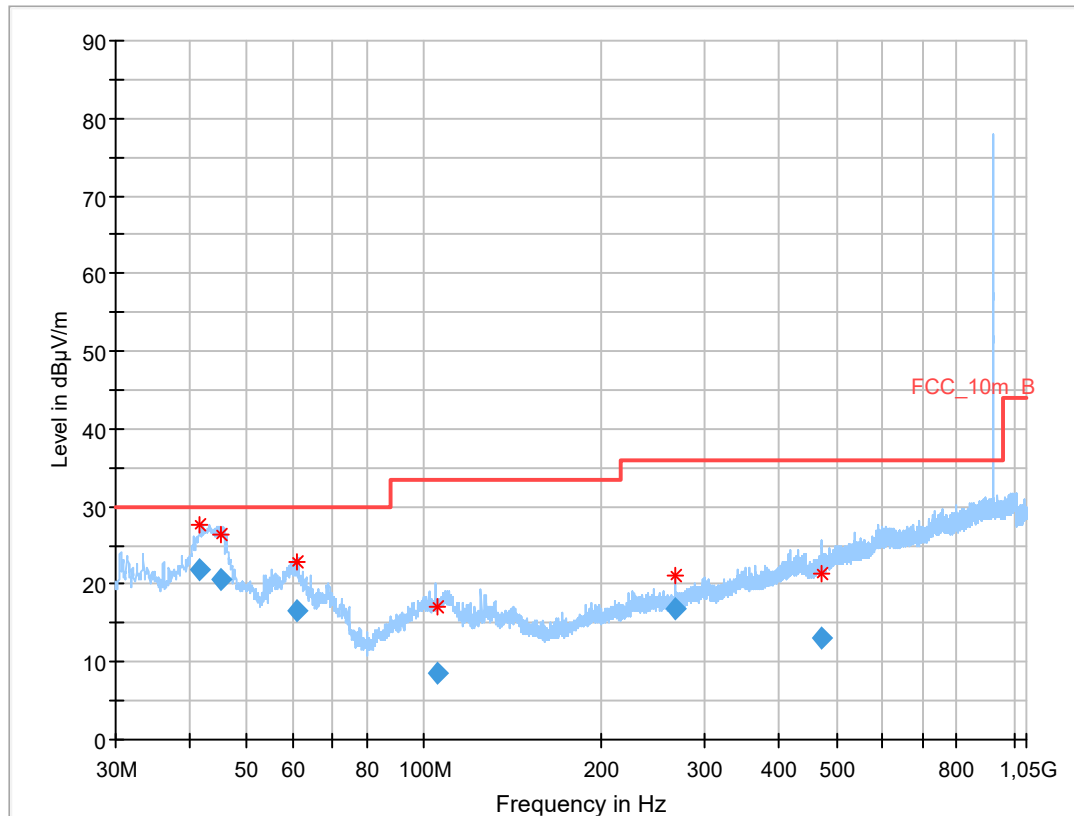
Limits:

FCC		IC
Band-edge Compliance of conducted and radiated emissions		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
Frequency / MHz	Field Strength / (dBµV/m)	Measurement distance / m
30 - 88	30.0	10
88 – 216	33.5	10
216 – 960	36.0	10
Above 960	54.0	3

Result:

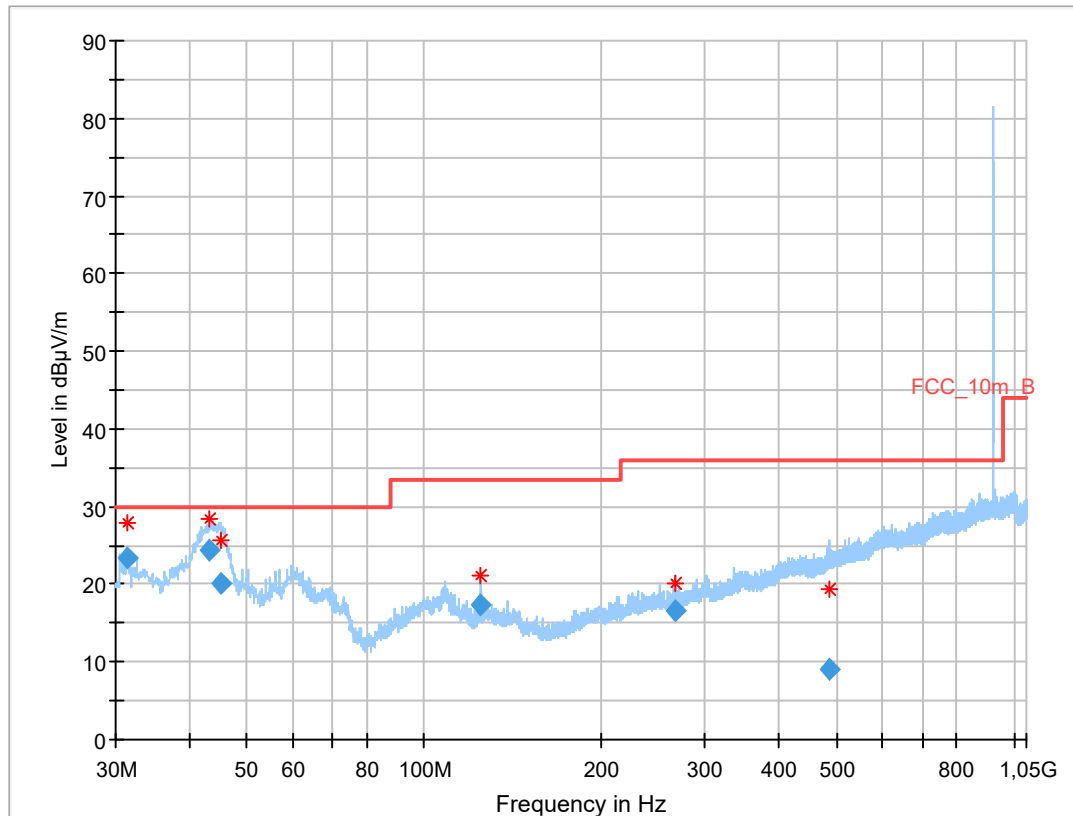
See result table below the plots.

Plot 1: 30 MHz – 1 GHz, horizontal & vertical polarisation (lowest channel)

**Final_Result**

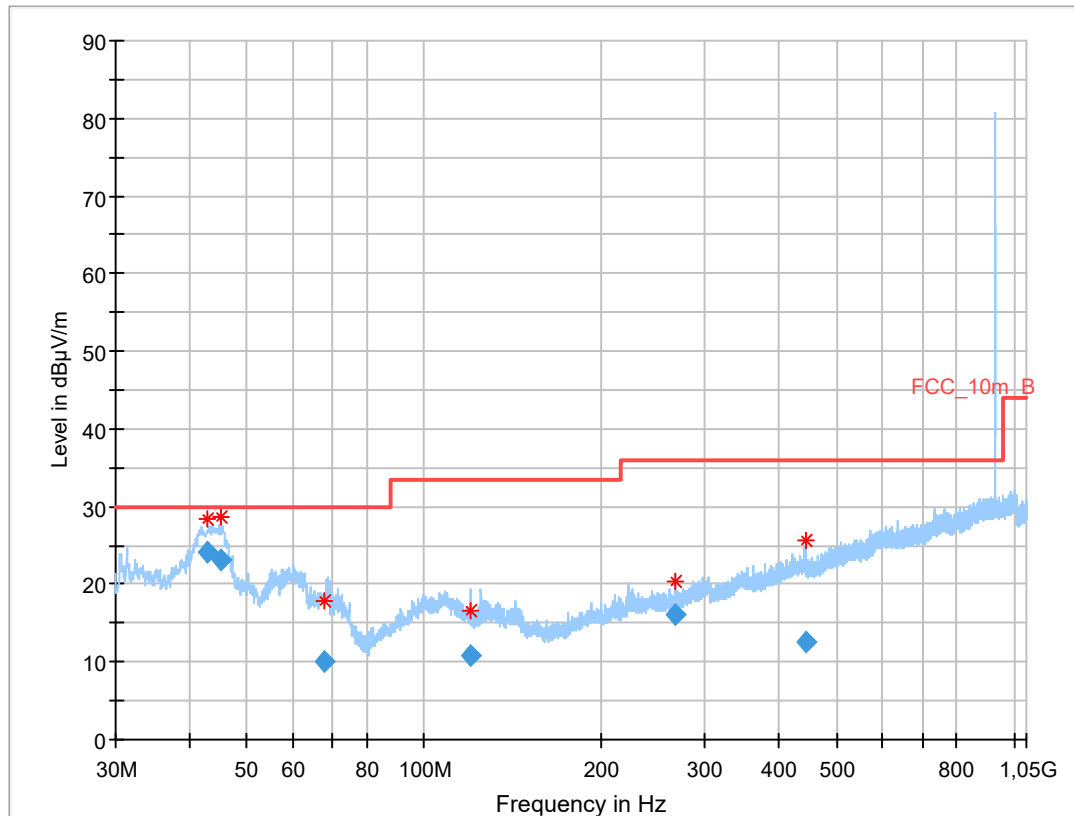
Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
41.498	21.93	30.0	8.1	1000	120.0	98.0	V	326	14
45.260	20.57	30.0	9.4	1000	120.0	216.0	V	90	14
60.833	16.49	30.0	13.5	1000	120.0	200.0	V	90	13
105.008	8.63	33.5	24.9	1000	120.0	116.0	V	175	13
265.999	16.90	36.0	19.1	1000	120.0	104.0	V	48	13
473.331	12.96	36.0	23.0	1000	120.0	103.0	V	239	18

Plot 2: 30 MHz – 1 GHz, horizontal & vertical polarisation (middle channel)

**Final_Result**

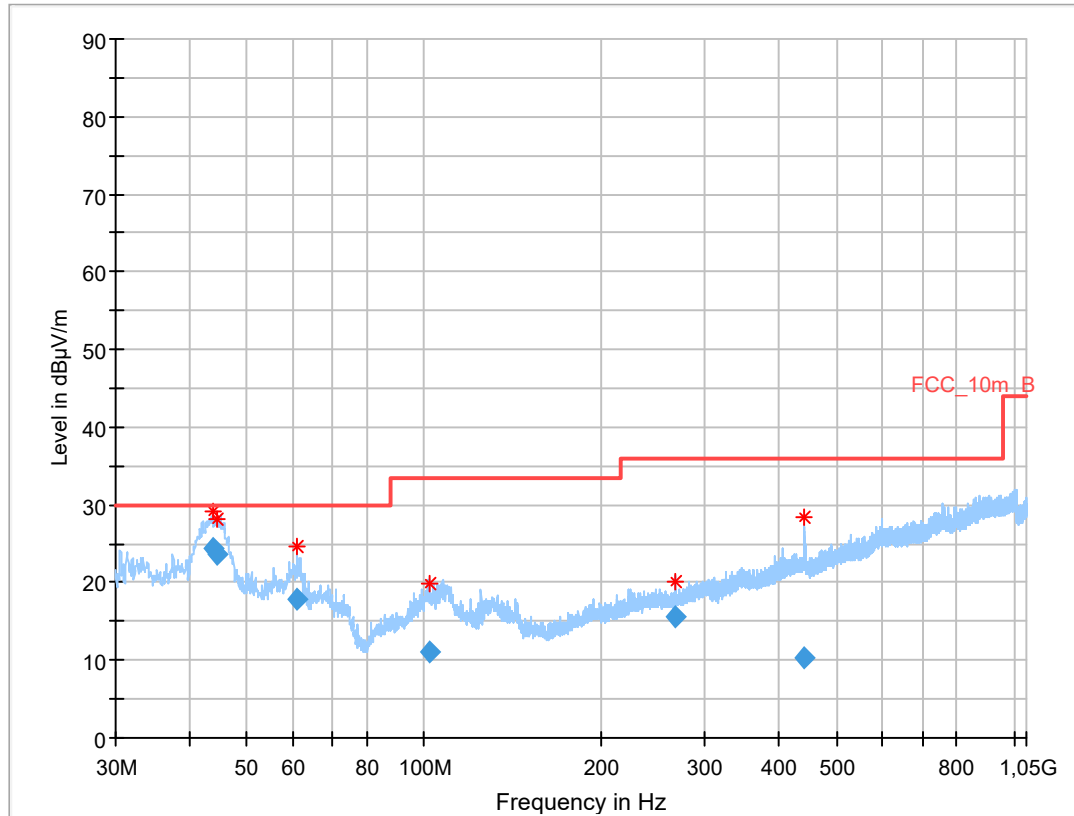
Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
31.420	23.35	30.0	6.7	1000	120.0	113.0	V	123	12
43.295	24.40	30.0	5.6	1000	120.0	100.0	V	334	14
45.243	20.00	30.0	10.0	1000	120.0	203.0	V	180	14
124.990	17.26	33.5	16.2	1000	120.0	120.0	V	35	9
265.993	16.62	36.0	19.4	1000	120.0	103.0	V	45	13
485.573	9.08	36.0	26.9	1000	120.0	391.0	V	197	18

Plot 3: 30 MHz – 1 GHz, horizontal & vertical polarisation (highest channel)

**Final_Result**

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
42.761	24.06	30.0	5.9	1000	120.0	100.0	V	348	14
45.273	23.14	30.0	6.9	1000	120.0	228.0	V	180	14
67.907	10.14	30.0	19.9	1000	120.0	245.0	V	0	10
119.960	10.88	33.5	22.6	1000	120.0	204.0	V	45	10
265.996	16.18	36.0	19.8	1000	120.0	134.0	V	56	13
442.962	12.64	36.0	23.4	1000	120.0	177.0	V	0	17

Plot 4: 30 MHz – 1 GHz, horizontal & vertical polarisation (RX-Mode)

**Final_Result**

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB/m)
43.778	24.28	30.0	5.7	1000	120.0	103.0	V	130	14
44.447	23.57	30.0	6.4	1000	120.0	204.0	V	180	14
60.800	17.82	30.0	12.2	1000	120.0	200.0	V	154	13
101.883	10.94	33.5	22.6	1000	120.0	165.0	V	22	13
265.988	15.52	36.0	20.5	1000	120.0	120.0	V	40	13
441.368	10.21	36.0	25.8	1000	120.0	136.0	V	90	17

12.8.2 Spurious emissions radiated above 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode. The measurement is performed in the mode with the highest output power.

Measurement:

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 x RBW
Span	1 GHz to 12.75 GHz
Trace mode	Max hold
Test setup	See sub clause 7.2 C, D (1 GHz – 12.75 GHz)
Measurement uncertainty	See sub clause 9

The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

ANSI C63.10
The average emission shall be determined by using Video averaging (VBW = 10 Hz). If the dwell time of the hopping signal is less than 100 ms (per channel), the VBW=10 Hz reading may be adjusted by a factor: $F = 20 \log(\text{dwell time}/100 \text{ ms})$

FCC		IC
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209		
Frequency / MHz	Field strength / (dBµV/m)	Measurement distance / m
Above 960	54.0	3

Result:

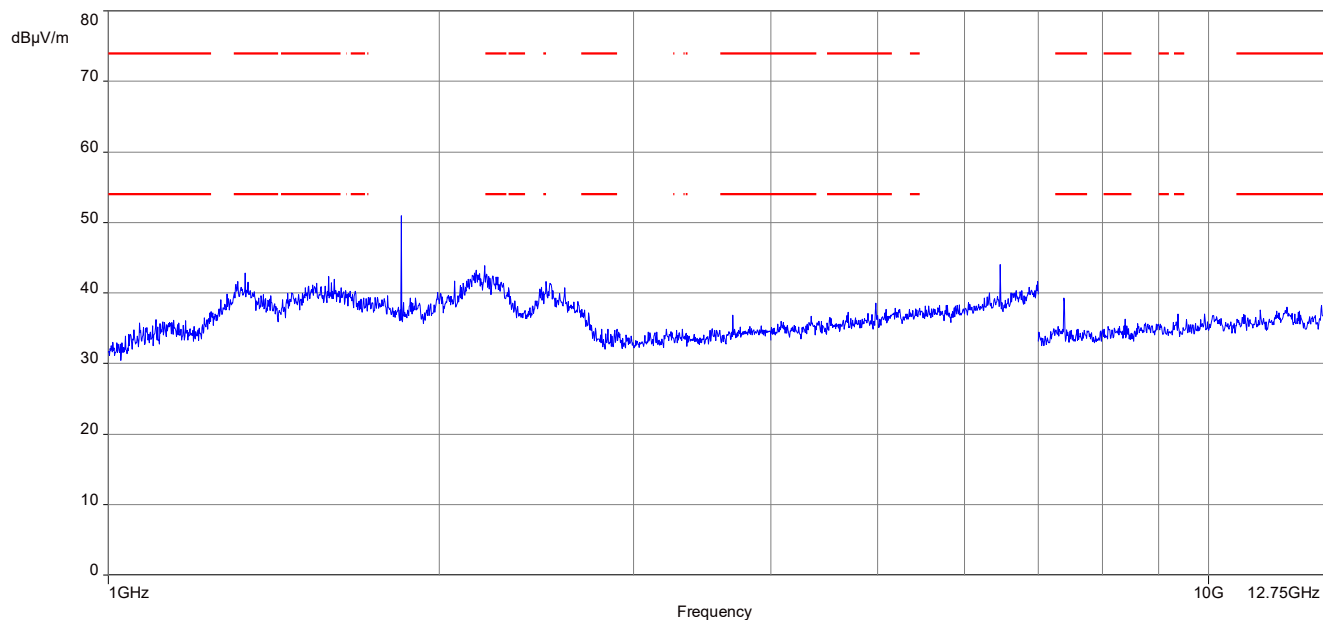
For radiated spurious emission the limits of 15.209 applies for all frequencies mentioned in 15.205. According to FCC Public Notice DA 00-705 (ANSI C63.10) the average emission shall be determined by using Video averaging (VBW = 10 Hz). If the dwell time of the hopping signal is less than 100 ms (per channel), the VBW=10 Hz reading may be adjusted by a factor:

$$F = 20 \cdot \log (\text{dwell time} / 100 \text{ ms})$$

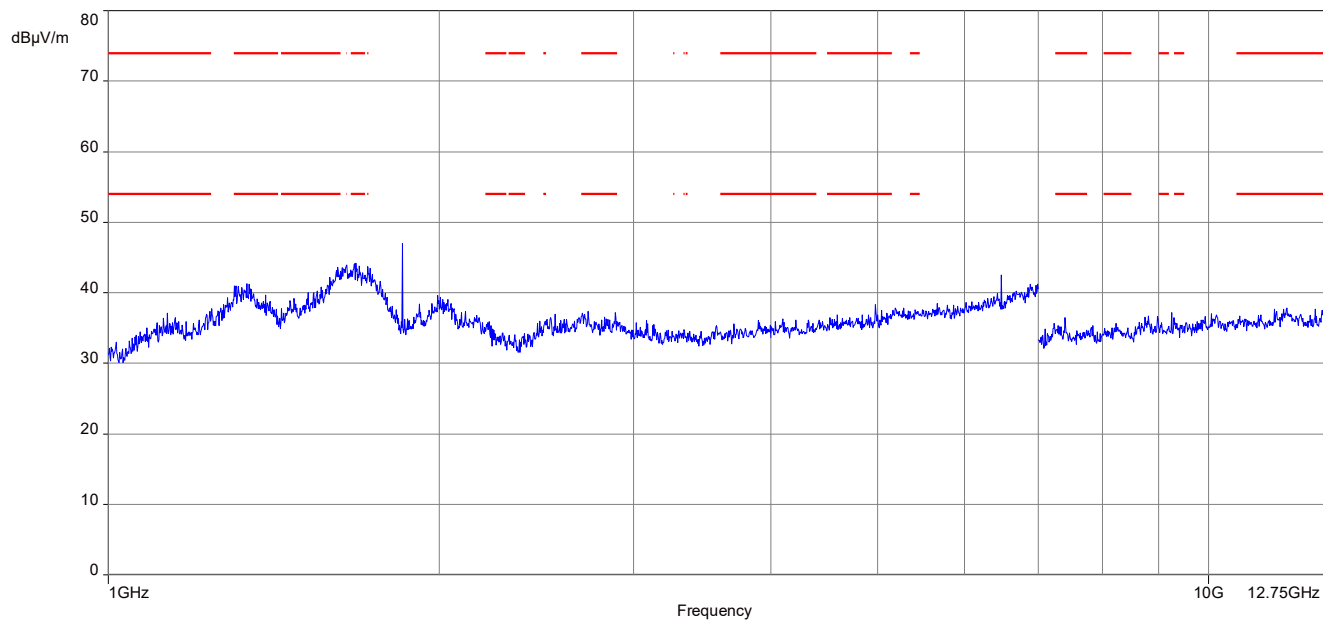
TX spurious emissions radiated								
Lowest channel			Middle channel			Highest channel		
Frequency / MHz	Detector	Level / (dBμV/m)	Frequency / MHz	Detector	Level / (dBμV/m)	Frequency / MHz	Detector	Level / (dBμV/m)
All emissions were more than 10 dB below the limit in Peak and Average.								

Plots:

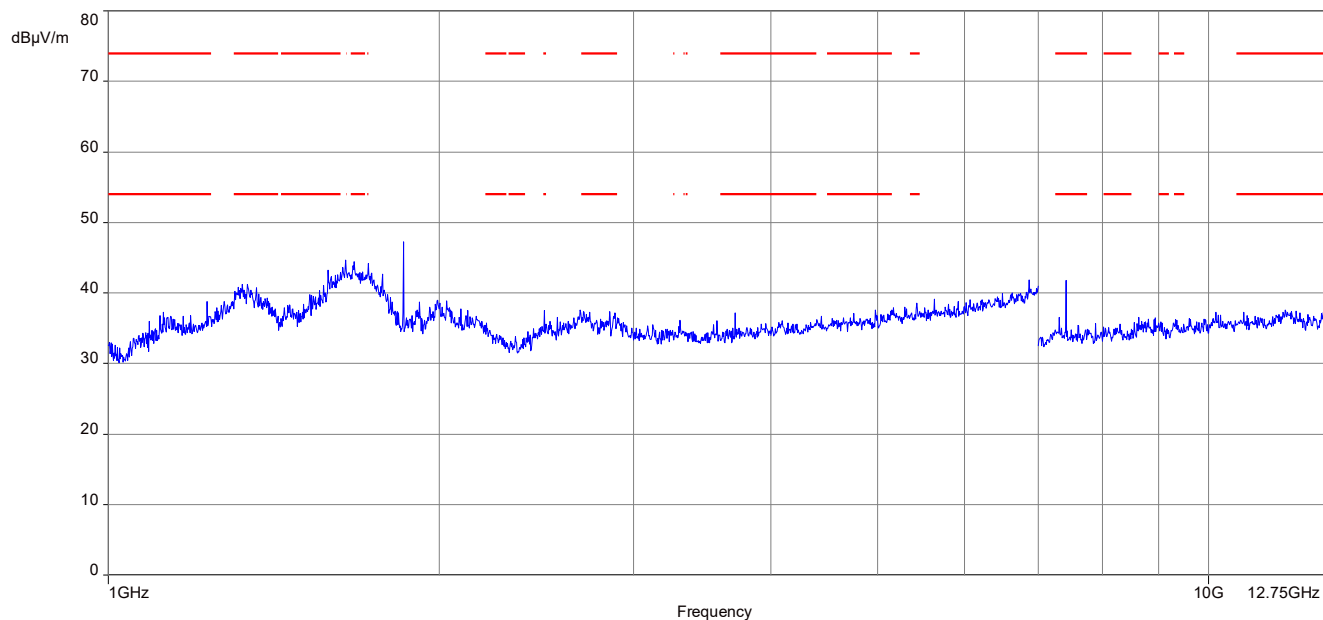
Plot 1: 1 GHz – 12.75 GHz, horizontal & vertical polarisation (lowest channel)



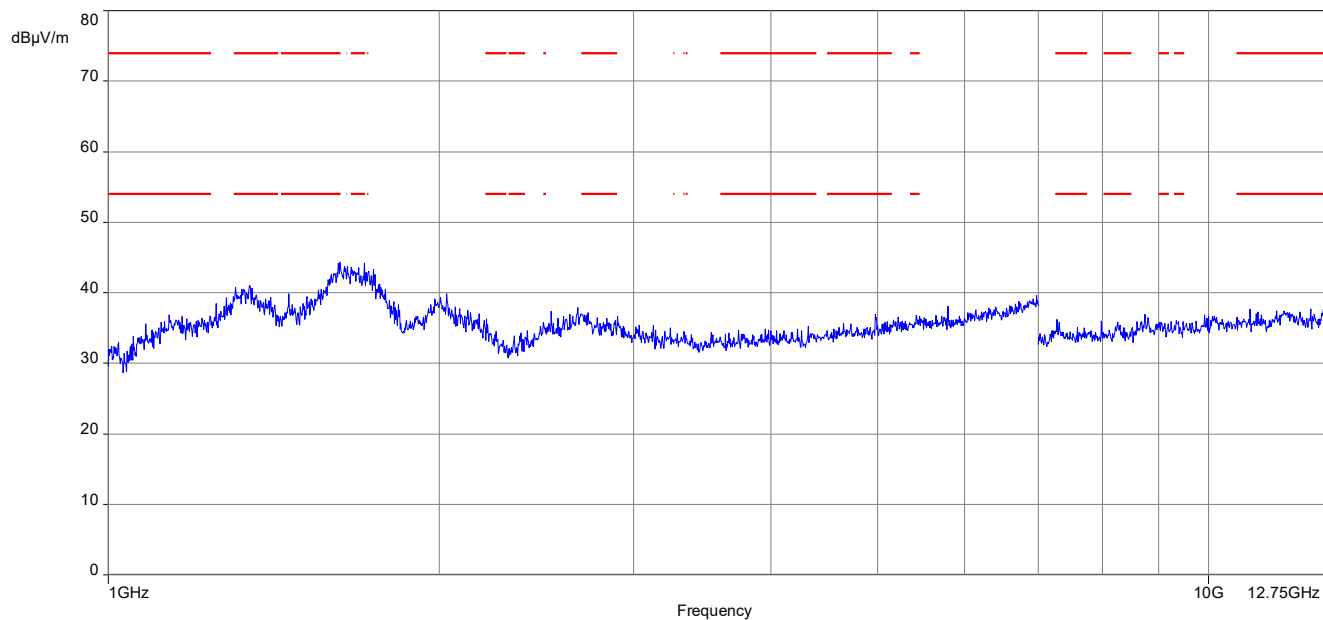
Plot 2: 1 GHz – 12.75 GHz, horizontal & vertical polarisation (middle channel)



Plot 3: 1 GHz – 12.75 GHz, horizontal & vertical polarisation (highest channel)



Plot 4: 1GHz – 12.75 GHz, RX-Mode, horizontal & vertical polarisation



12.9 Spurious emissions conducted below 30 MHz (AC conducted)

Description:

Measurement of the conducted spurious emissions in transmit mode below 30 MHz. Both power lines, phase and neutral line, are measured. Found peaks are re-measured with average and quasi peak detection to show compliance to the limits.

Measurement:

Measurement parameter	
Detector	Peak - Quasi Peak / Average
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 100 kHz
Span	9 kHz to 30 MHz
Trace mode	Max. hold
Test setup	See chapter 7.3A
Measurement uncertainty	See chapter 9

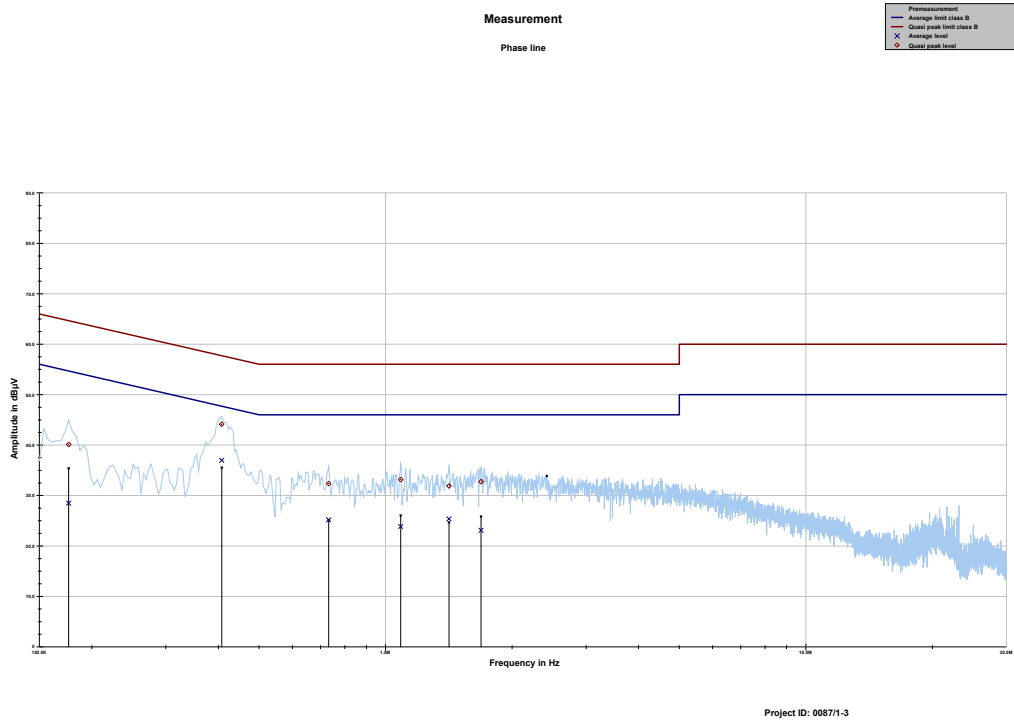
Limits:

FCC		IC
Frequency / MHz)	Quasi-Peak / (dB μ V / m)	Average / (dB μ V / m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 – 30.0	60	50

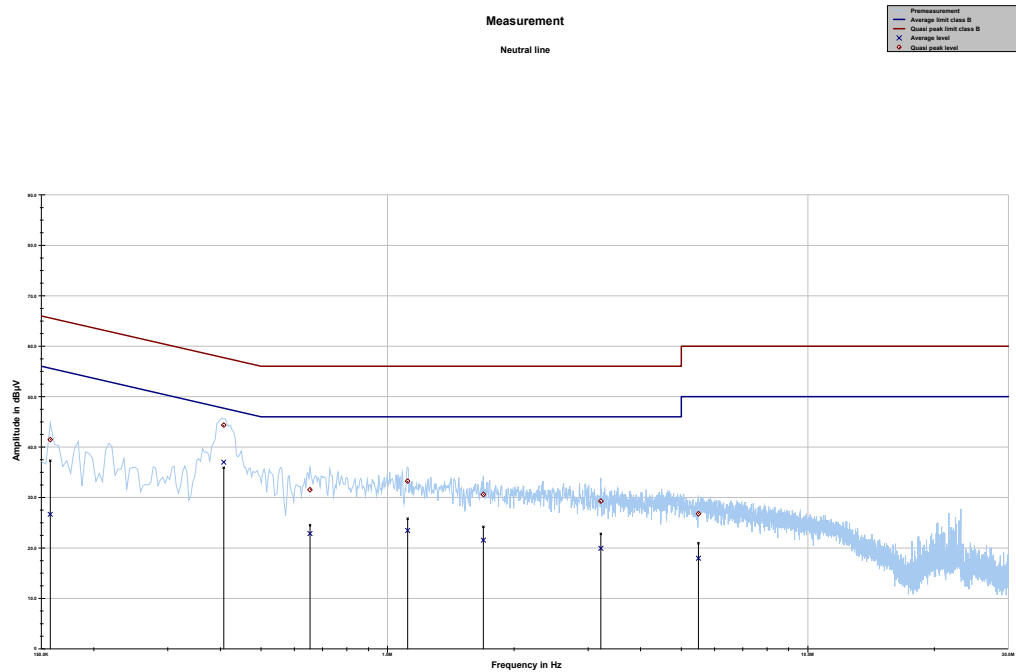
*Decreases with the logarithm of the frequency

Results:

TX spurious emissions conducted < 30 MHz / (dB μ V / m) @ 3m		
f / MHz	Detector	Level / dB μ V/m
See result table below the plots.		

Plots:**Plot 1:** 150 kHz to 30 MHz, phase line**Final_Result**

Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.176119	40.10	24.57	64.667	28.48	26.77	55.254
0.407456	44.12	13.58	57.700	36.98	11.67	48.644
0.732075	32.36	23.64	56.000	25.17	20.83	46.000
1.086544	33.15	22.85	56.000	23.85	22.15	46.000
1.414894	31.90	24.10	56.000	25.35	20.65	46.000
1.687275	32.74	23.26	56.000	23.10	22.90	46.000

Plot 2: 150 kHz to 30 MHz, neutral line**Final_Result**

Frequency	Quasi peak level	Margin quasi peak	Limit QP	Average level	Margin Average	Limit AV
MHz	dBµV	dB	dBµV	dBµV	dB	dBµV
0.157463	41.48	24.12	65.597	26.66	29.13	55.787
0.407456	44.35	13.35	57.700	37.00	11.64	48.644
0.653719	31.52	24.48	56.000	22.85	23.15	46.000
1.116394	33.25	22.75	56.000	23.46	22.54	46.000
1.691006	30.59	25.41	56.000	21.54	24.46	46.000
3.217087	29.26	26.74	56.000	19.91	26.09	46.000
5.493150	26.76	33.24	60.000	17.96	32.04	50.000

13 Observations

No observations except those reported with the single test cases have been made.

14 Glossary

EUT	Equipment under test
DUT	Device under test
UUT	Unit under test
GUE	GNSS User Equipment
ETSI	European Telecommunications Standards Institute
EN	European Standard
FCC	Federal Communications Commission
FCC ID	Company Identifier at FCC
IC	Industry Canada
PMN	Product marketing name
HMN	Host marketing name
HVIN	Hardware version identification number
FVIN	Firmware version identification number
EMC	Electromagnetic Compatibility
HW	Hardware
SW	Software
Inv. No.	Inventory number
S/N or SN	Serial number
C	Compliant
NC	Not compliant
NA	Not applicable
NP	Not performed
PP	Positive peak
QP	Quasi peak
AVG	Average
OC	Operating channel
OCW	Operating channel bandwidth
OBW	Occupied bandwidth
OOB	Out of band
DFS	Dynamic frequency selection
CAC	Channel availability check
OP	Occupancy period
NOP	Non occupancy period
DC	Duty cycle
PER	Packet error rate
CW	Clean wave
MC	Modulated carrier
WLAN	Wireless local area network
RLAN	Radio local area network
DSSS	Dynamic sequence spread spectrum
OFDM	Orthogonal frequency division multiplexing
FHSS	Frequency hopping spread spectrum
GNSS	Global Navigation Satellite System
C/N₀	Carrier to noise-density ratio, expressed in dB-Hz

15 Document history

Version	Applied changes	Date of release
-/-	Initial release	2020-08-19
-A	Correction of output power and OBW99% measurements	2020-10-08

16 Accreditation Certificate – D-PL-12076-01-04

first page	last page
 Deutsche Akkreditierungsstelle GmbH Entrusted according to Section 8 subsection 1 AkkStelleG in connection with Section 1 subsection 1 AkkStelleGBV Signatory to the Multilateral Agreements of EA, ILAC and IAF for Mutual Recognition Accreditation  The Deutsche Akkreditierungsstelle GmbH attests that the testing laboratory CTC advanced GmbH Untertürkheimer Straße 6-10, 66117 Saarbrücken is competent under the terms of DIN EN ISO/IEC 17025:2005 to carry out tests in the following fields: Telecommunication (TC) and Electromagnetic Compatibility (EMC) for Canadian Standards The accreditation certificate shall only apply in connection with the notice of accreditation of 11.01.2019 with the accreditation number D-PL-12076-01 and is valid until 21.04.2021. It comprises the cover sheet, the reverse side of the cover sheet and the following annex with a total of 7 pages. Registration number of the certificate: D-PL-12076-01-04 Frankfurt am Main, 11.01.2019  Uwe Zimmermann Head of Division See notes covered	Deutsche Akkreditierungsstelle GmbH Office Berlin Spinnmarkt 10 10117 Berlin Office Frankfurt am Main Europa-Allee 52 60327 Frankfurt am Main Office Braunschweig Bundesallee 150 38116 Braunschweig The publication of extracts of the accreditation certificate is subject to the prior written approval by Deutsche Akkreditierungsstelle GmbH (DAkkS). Exempted is the unchanged form of separate disseminations of the cover sheet by the conformity assessment body mentioned overleaf. No impression shall be made that the accreditation also extends to fields beyond the scope of accreditation attested by DAkkS. The accreditation was granted pursuant to the Act on the Accreditation Body (AkkStelleG) of 31 July 2009 (Federal Law Gazette I p. 2625) and the Regulation (EC) No 765/2008 of the European Parliament and of the Council of 9 July 2008 setting out the requirements for accreditation and market surveillance relating to the marketing of products (Official Journal of the European Union L 218 of 9 July 2008, p. 30). DAkkS is a signatory to the Multilateral Agreements for Mutual Recognition of the European co-operation for Accreditation (EA), International Accreditation Forum (IAF) and International Laboratory Accreditation Cooperation (ILAC). The signatories to these agreements recognise each other's accreditations. The up-to-date state of membership can be retrieved from the following websites: EA: www.european-accreditation.org ILAC: www.ilac.org IAF: www.iaf.eu

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17 Accreditation Certificate – D-PL-12076-01-05

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END OF TEST REPORT